

A photograph of a lush, green garden. In the foreground, there are several large, dark tree trunks and dense foliage. A wooden bench is visible in the middle ground, partially obscured by the trees. The background shows a light-colored building. The overall scene is a serene, natural setting.

CENTRO BRASILEIRO DE PESQUISAS FÍSICAS

<http://www.cbpf.br>

MICROSCOPIA ELETRÔNICA



ANDRÉ LUIZ PINTO



CBPF

Roteiro



- Introdução
- Fundamentos
 - Fontes de elétrons
 - Lentes de elétrons
 - Interação elétron-matéria
- Microscópio Eletrônico de Varredura
- Microscópio Eletrônico de Transmissão
- Aplicações à Nanotecnologia
- Comentários Finais
 - LabNano

Opções para visualizar a microestrutura

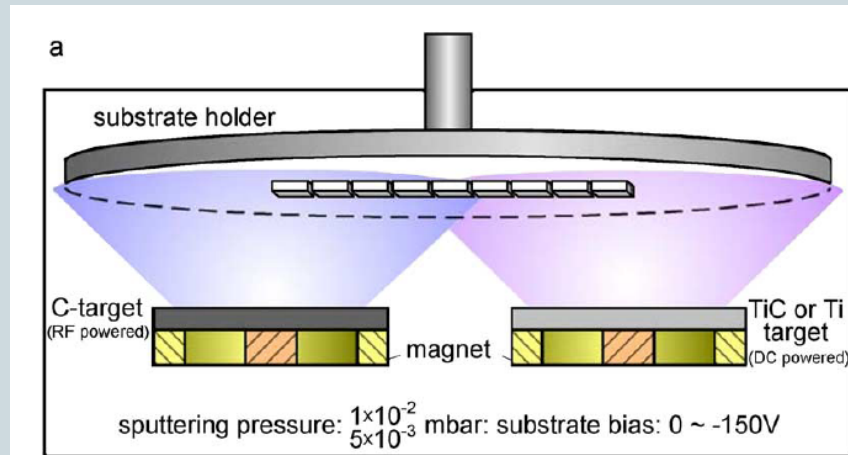


- Aumento x Resolução (lateral)



- Olho humano – 0,1 mm
- Microscopia Ótica – 0,5 μm
- Microscópio Eletrônico de Varredura (MEV) – 1 - 4 ηm
- Microscópio Eletrônico de Transmissão (MET) – 0,8 - 1,4 Å
- Microscópio de Ponta de Prova (SPM) – 0,3 Å

Revestimento nc-TiC/a-C



Pei et al. (2005)

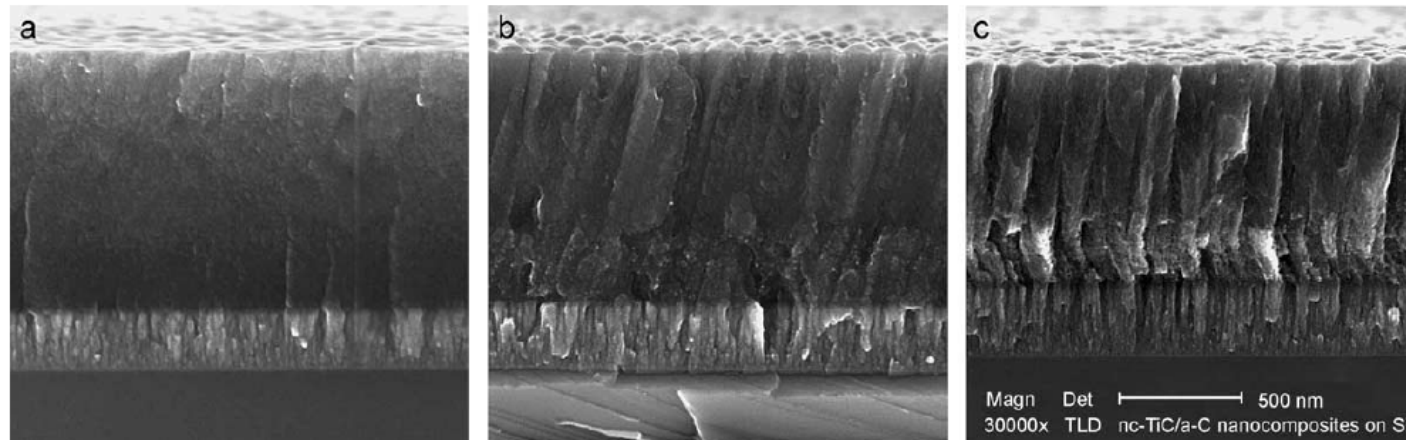


Fig. 2. SEM micrographs of the fractured cross-sections showing the transition from glassy to columnar growth of nc-TiC/a-C coatings with Ti content (at.%) of (a) 10, (b) 17 and (c) 34.

Revestimento nc-TiC/a-C

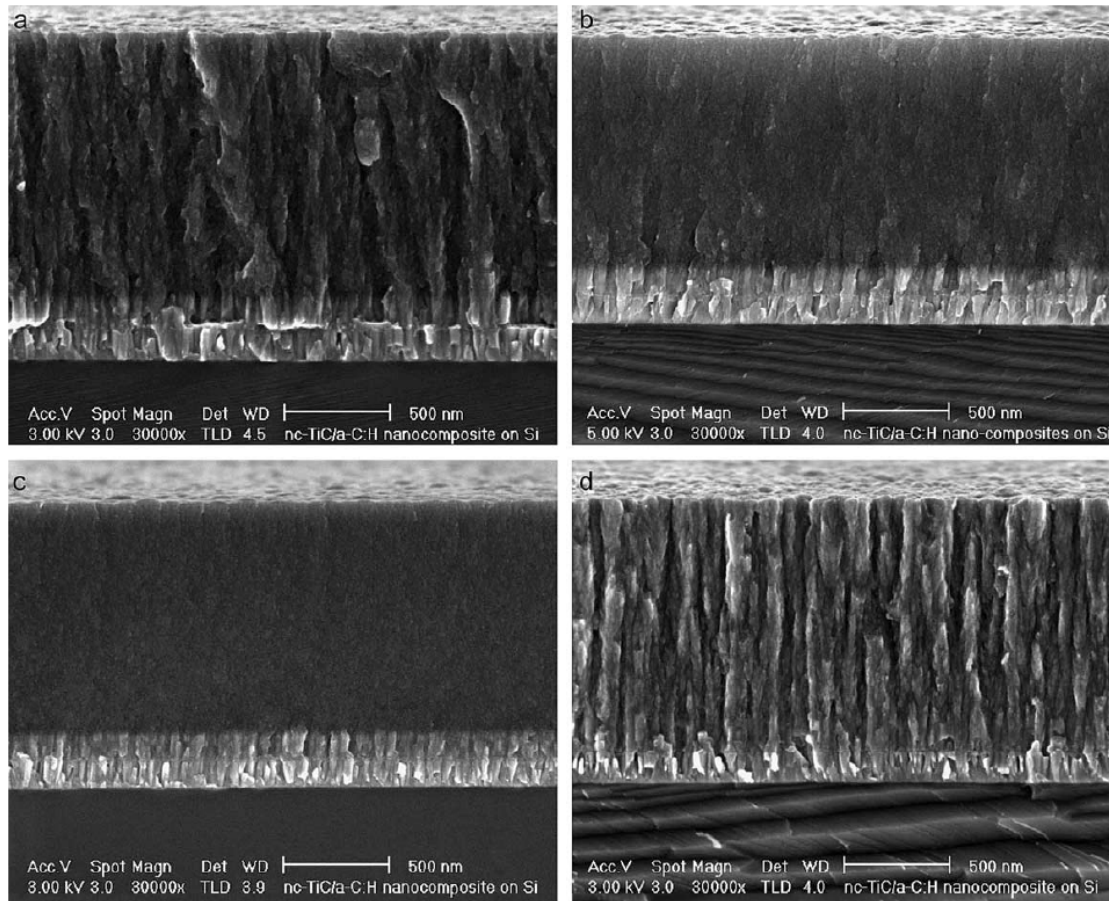


Fig. 3. SEM micrographs of fractured cross-sections showing the transition from columnar to glassy structures of nc-TiC/a-C:H coatings deposited under different conditions: (a) 110 sccm C_2H_2 and -60 V bias; (b) 110 sccm C_2H_2 and -100 V bias; (c) 110 sccm C_2H_2 and -150 V bias and (d) 80 sccm C_2H_2 and -100 V bias.

Pei et al. (2005)

Revestimento nc-TiC/a-C

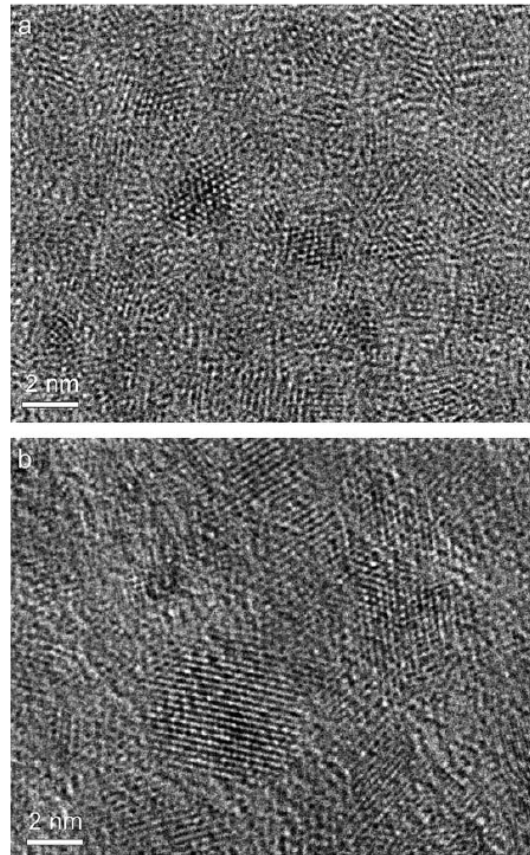


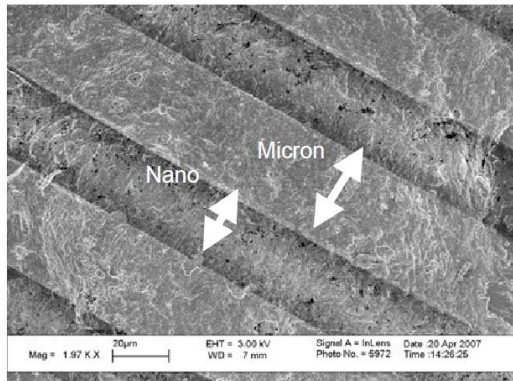
Fig. 4. HRTEM micrographs showing TiC nanocrystallites embedded in a-C:H matrix in nc-TiC/a-C:H nanocomposite: (a) coating HB3 with 17.84 at.% Ti and (b) coating HB5 with 31.75 at.% Ti.

Pei et al. (2005)

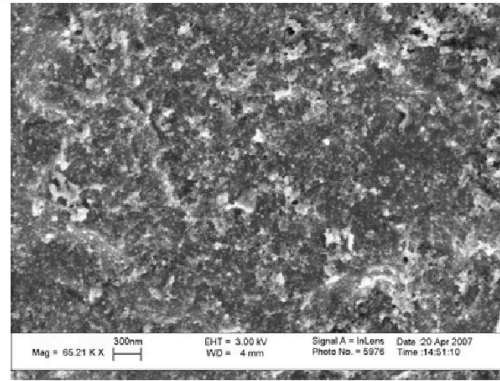
Nanoestruturação de superfícies



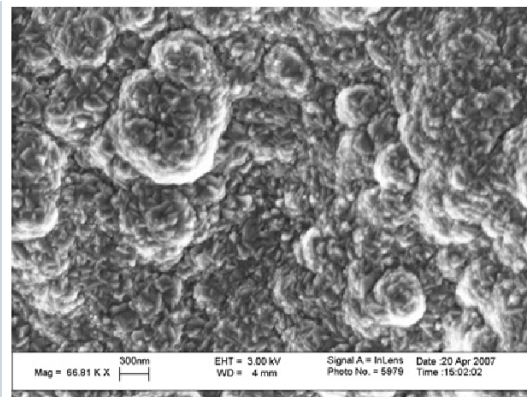
Nano region width = 22 μm ;
Micron region width = 40 μm



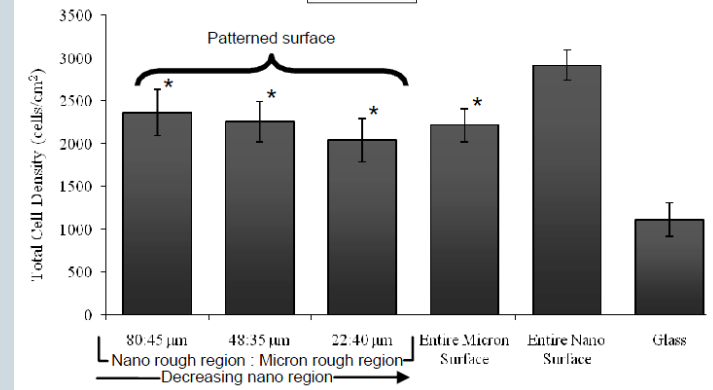
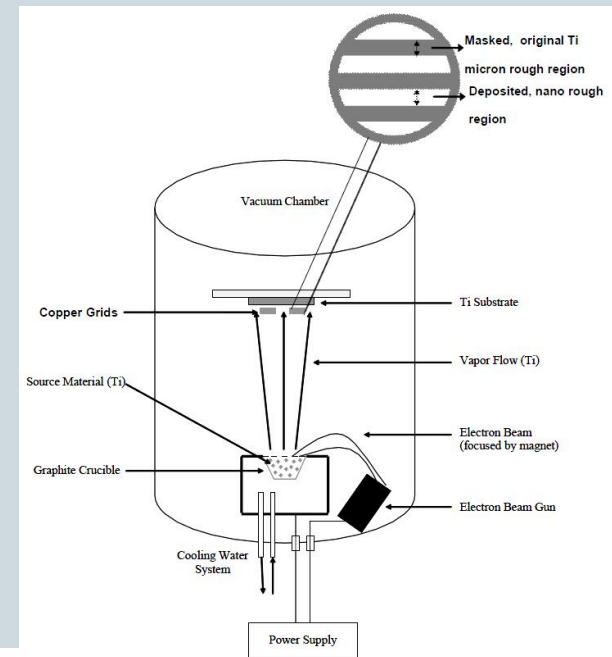
(g) Patterned Ti substrates
(scale bar = 20 μm)



(h) Micron region on patterned Ti substrate
(scale bar = 300 nm)

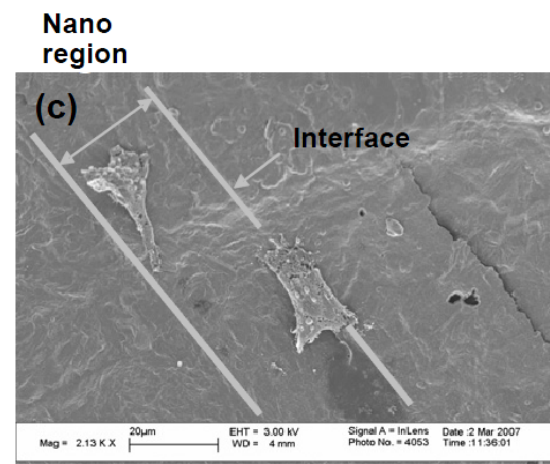
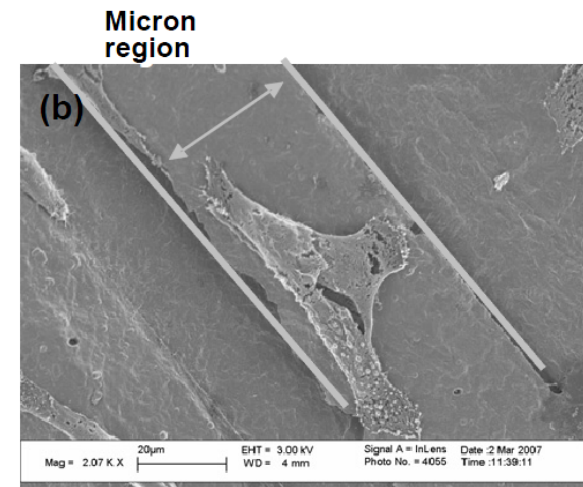
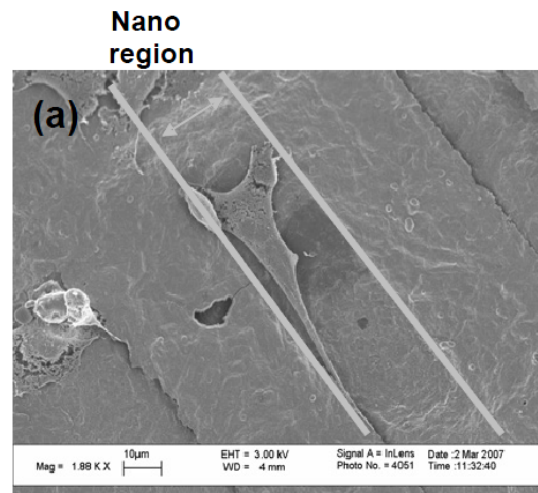


(i) Nano region on patterned Ti substrate
(scale bar = 300 nm)



Pucket et al. 2008

Sensitividade a modificações superficiais de biomateriais

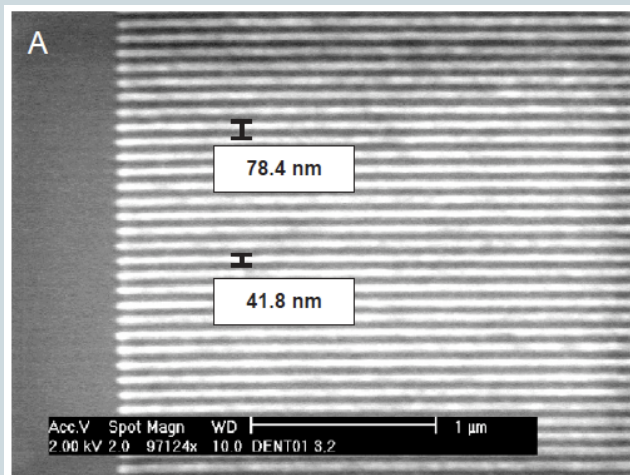


Pucket et al. 2008

Sensitividade a modificações superficiais de biomateriais



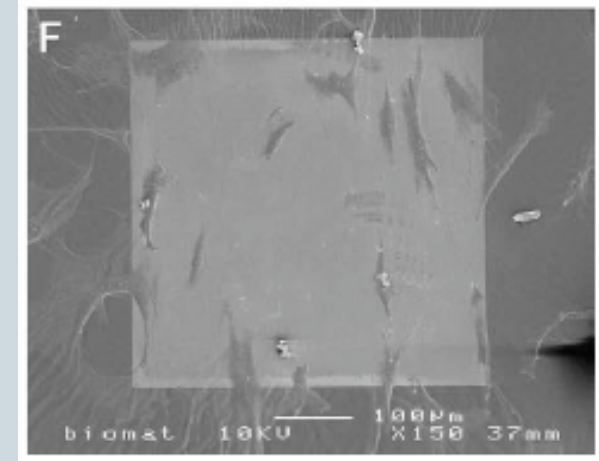
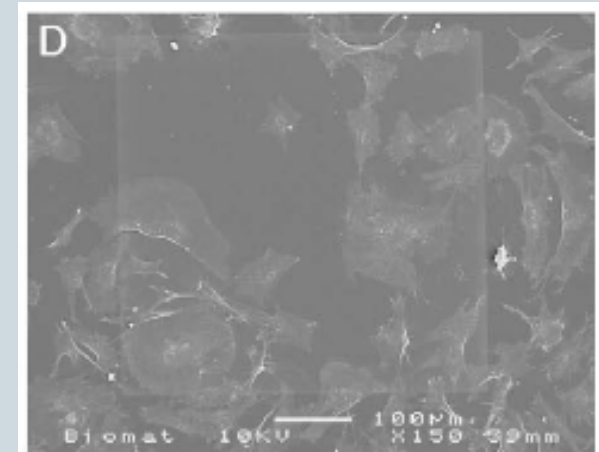
- Nanolitografia por Feixe de Elétrons para modificação superficial visando aumento da biocompatibilidade.
- Limite de sensibilidade por fibroblastos ~ 35 nm



Máscaras feitas por litografia de feixe de elétrons para identificar o limite de sensibilidade dos fibroblastos.

D – 15 nm

F – 35 nm



Nanocordas

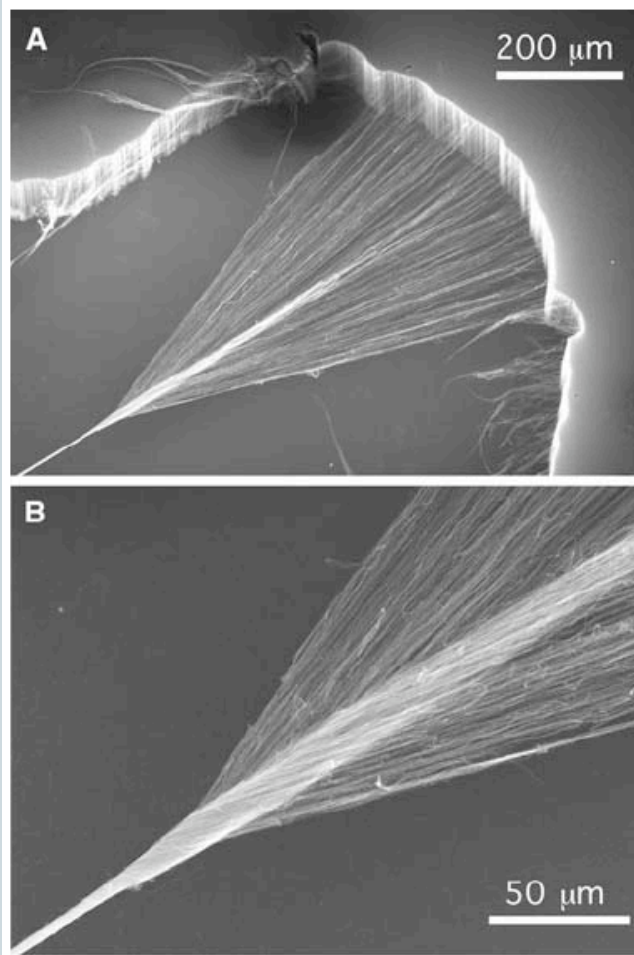


Fig. 1. (A and B) SEM images, at two different magnifications, of a carbon nanotube yarn in the process of being simultaneously drawn and twisted during spinning from a nanotube forest outside the SEM. The draw twist process was interrupted and the sample was transferred to a SEM for image recording. A forest strip (width $\sim 600 \mu\text{m}$) formed the pictured twisted yarn, $3.2 \mu\text{m}$ in diameter (fig. S2). The MWNTs, $\sim 10 \text{ nm}$ in diameter with length 10,000 times their width, form small bundles of a few nanotubes each in the forest, with individual nanotubes moving in and out of different bundles. The three-dimensional connectivity caused by intermittently switched bundling, visible in SEM micrographs, is believed to be important for the spinning process.

Zhang, M. et al.
Science 306, 2004, p.
1358-1361

Nanocordas

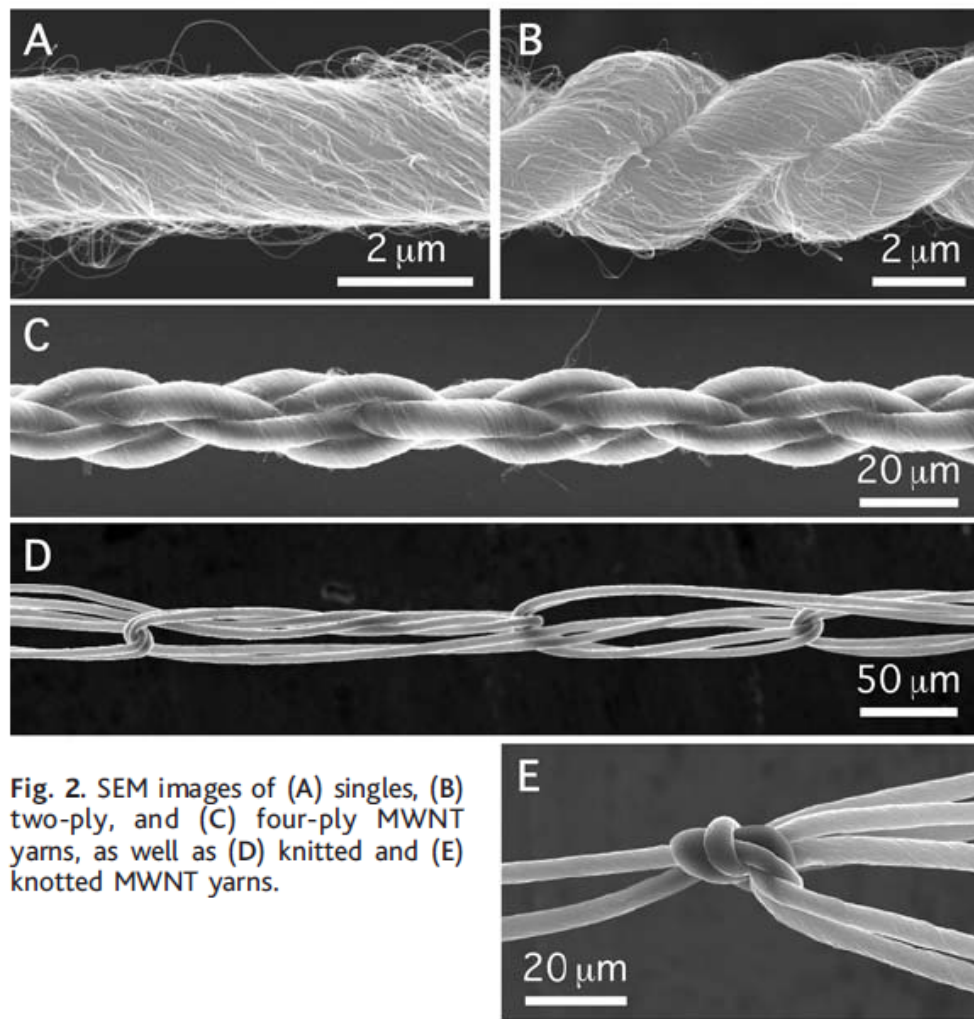


Fig. 2. SEM images of (A) singles, (B) two-ply, and (C) four-ply MWNT yarns, as well as (D) knitted and (E) knotted MWNT yarns.

Zhang, M. et al.
Science 306, 2004, p.
1358-1361

Nanocordas

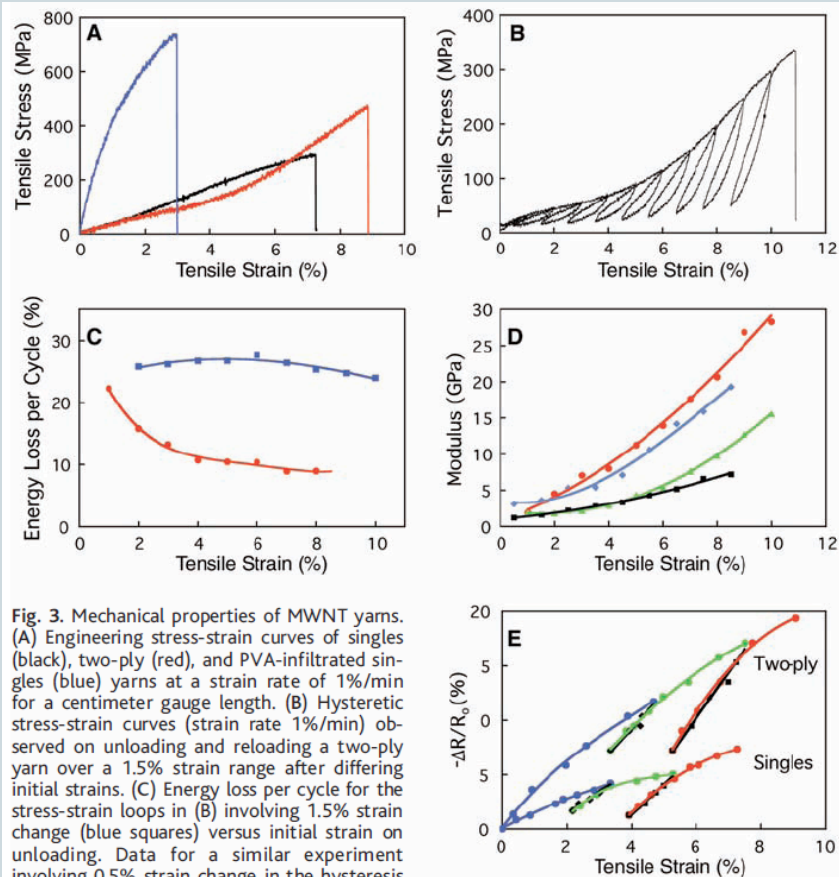


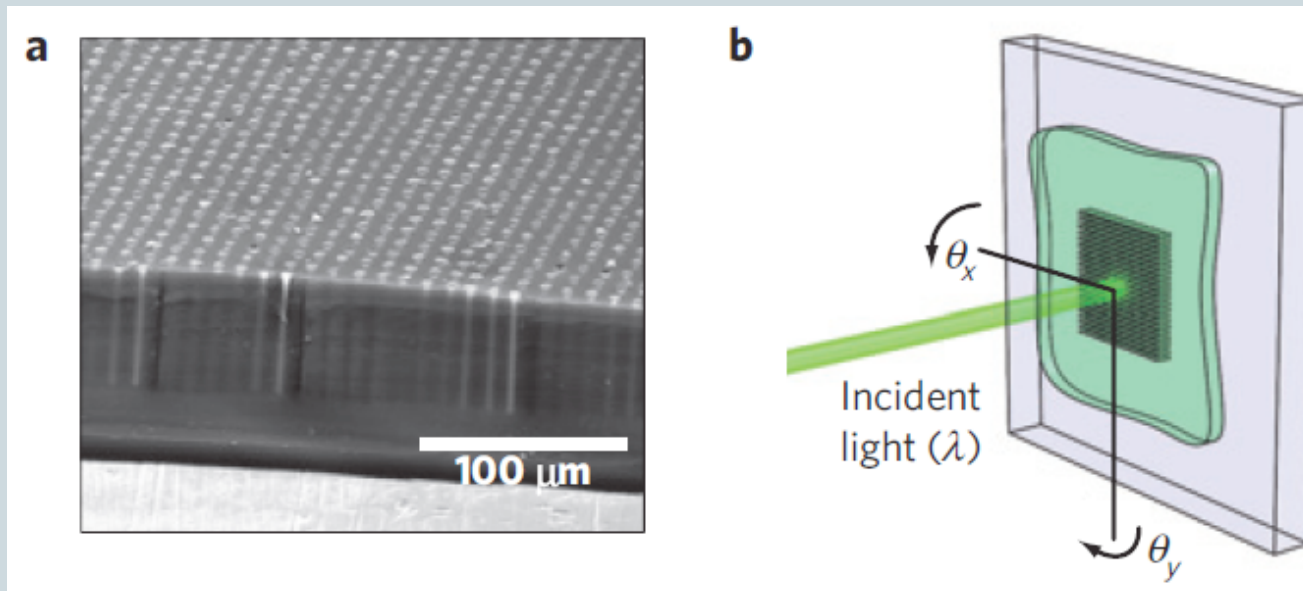
Fig. 3. Mechanical properties of MWNT yarns. (A) Engineering stress-strain curves of singles (black), two-ply (red), and PVA-infiltrated singles (blue) yarns at a strain rate of 1%/min for a centimeter gauge length. (B) Hysteretic stress-strain curves (strain rate 1%/min) observed on unloading and reloading a two-ply yarn over a 1.5% strain range after differing initial strains. (C) Energy loss per cycle for the stress-strain loops in (B) involving 1.5% strain change (blue squares) versus initial strain on unloading. Data for a similar experiment involving 0.5% strain change in the hysteresis loops are also shown (red circles). (D) Effective yarn moduli calculated for the stress-strain loops shown in (B) versus total tensile strain. Red circles and black squares are the effective moduli for the beginning and end of unloading, respectively; blue diamonds and green triangles are those for the beginning and end of reloading, respectively. (E) Percent change in diameter and length of a two-ply yarn (top) and a singles yarn (bottom) measured during yarn stretching in a SEM. Symbols: blue circles, initial stretch; black diamonds, first stress decrease; green circles, second stress increase; black squares, second stress decrease; red circles, stress increase until yarn rupture. Curves in (C) to (E) are guides for the eye.

Zhang, M. et al.
Science 306, 2004, p.
1358-1361

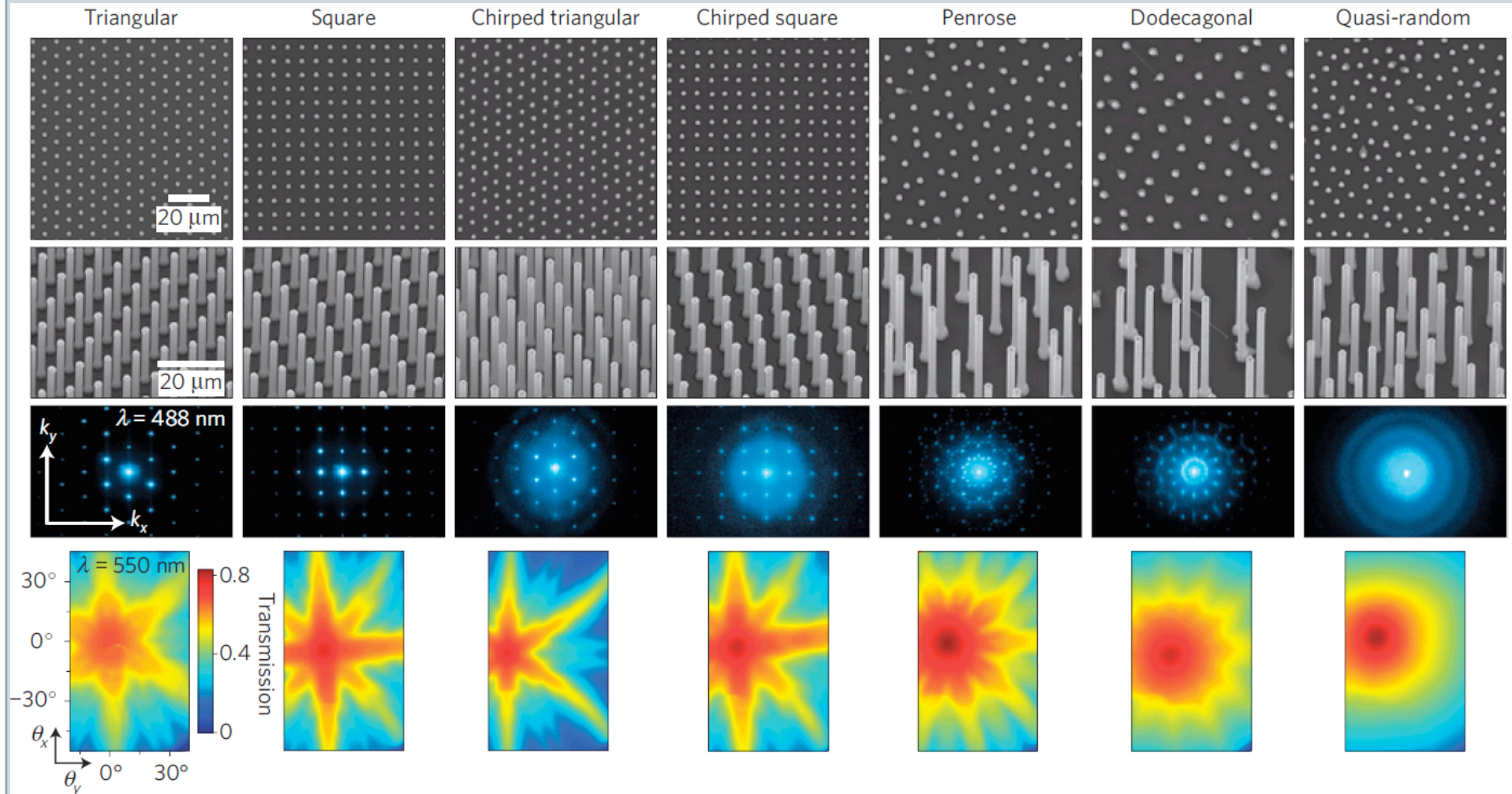
Nanofios de Si Células Fotovoltaicas



- Objetivos: flexibilidade mecânica, aumento na absorção e diminuição na quantidade de material



Nanofios de Si Células Fotovoltaicas



Cristais Fotônicos

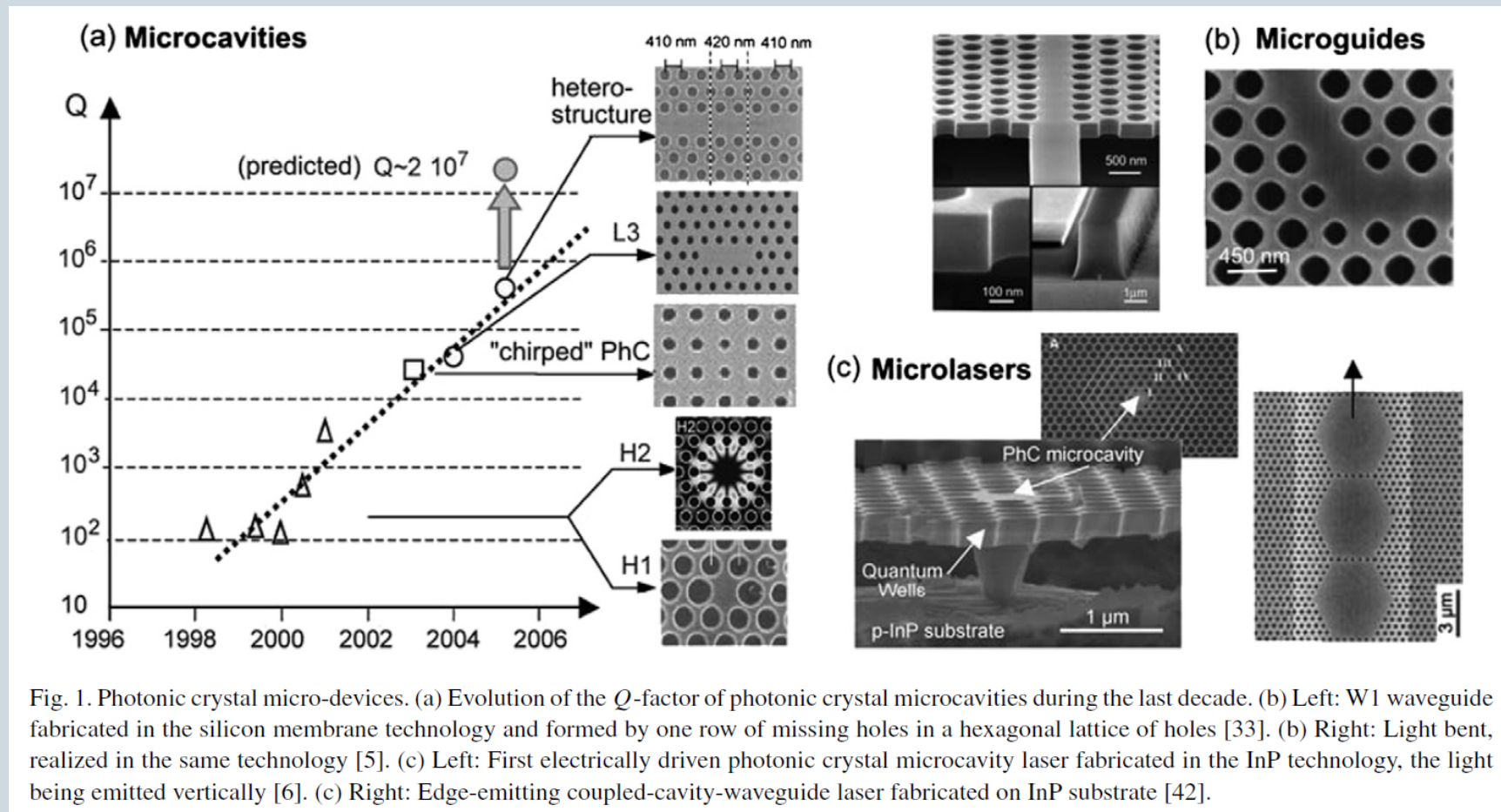
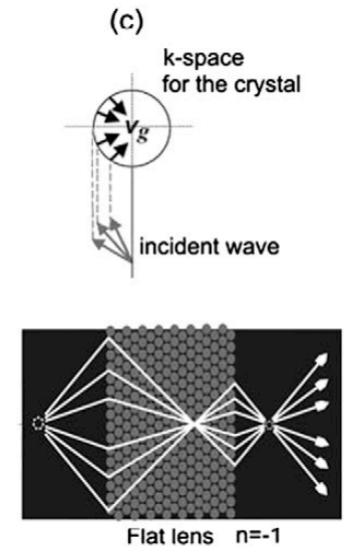
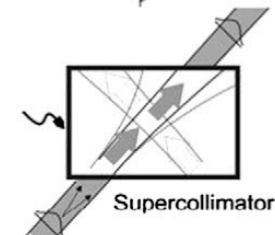
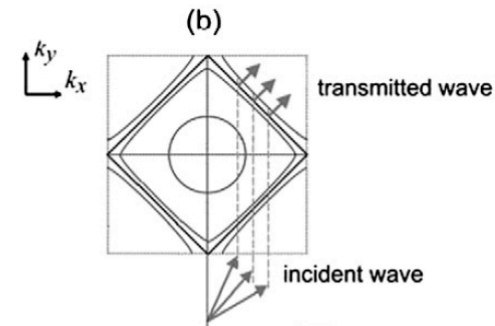
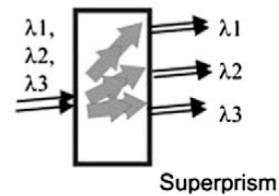
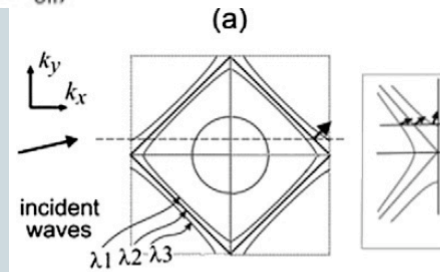
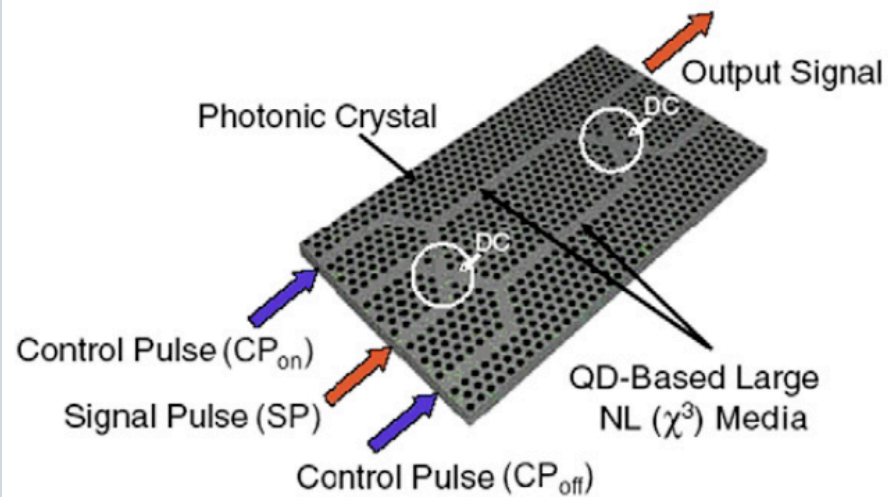


Fig. 1. Photonic crystal micro-devices. (a) Evolution of the Q -factor of photonic crystal microcavities during the last decade. (b) Left: W1 waveguide fabricated in the silicon membrane technology and formed by one row of missing holes in a hexagonal lattice of holes [33]. (b) Right: Light bent, realized in the same technology [5]. (c) Left: First electrically driven photonic crystal microcavity laser fabricated in the InP technology, the light being emitted vertically [6]. (c) Right: Edge-emitting coupled-cavity-waveguide laser fabricated on InP substrate [42].

Cristais Fotônicos



Cristais Fotônicos

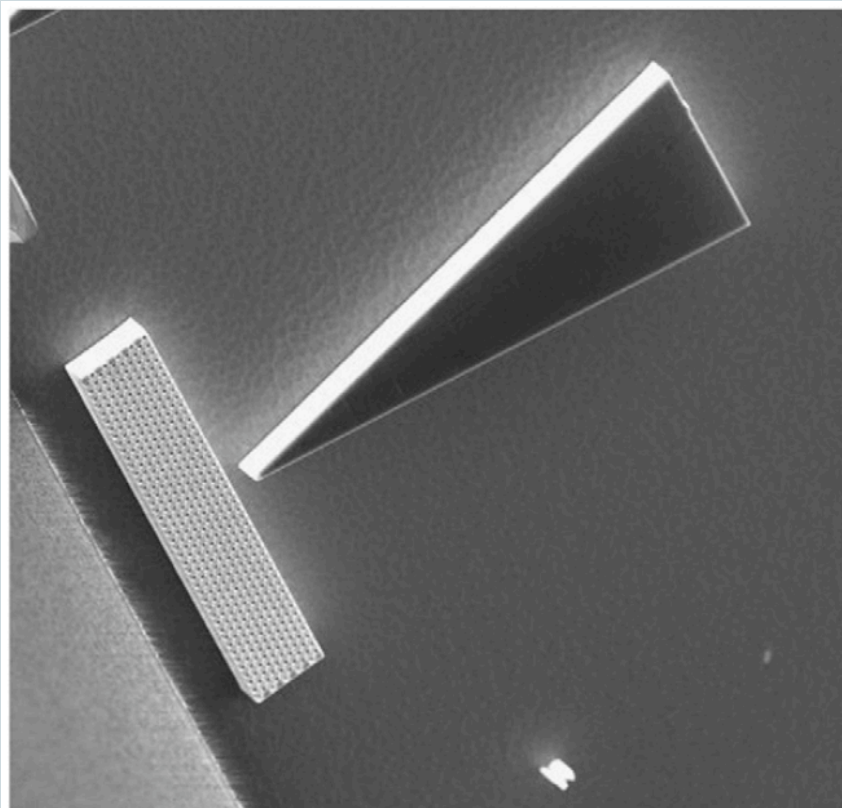


Fig. 16. SEM of a flat lens fed by a tapered optical waveguide.

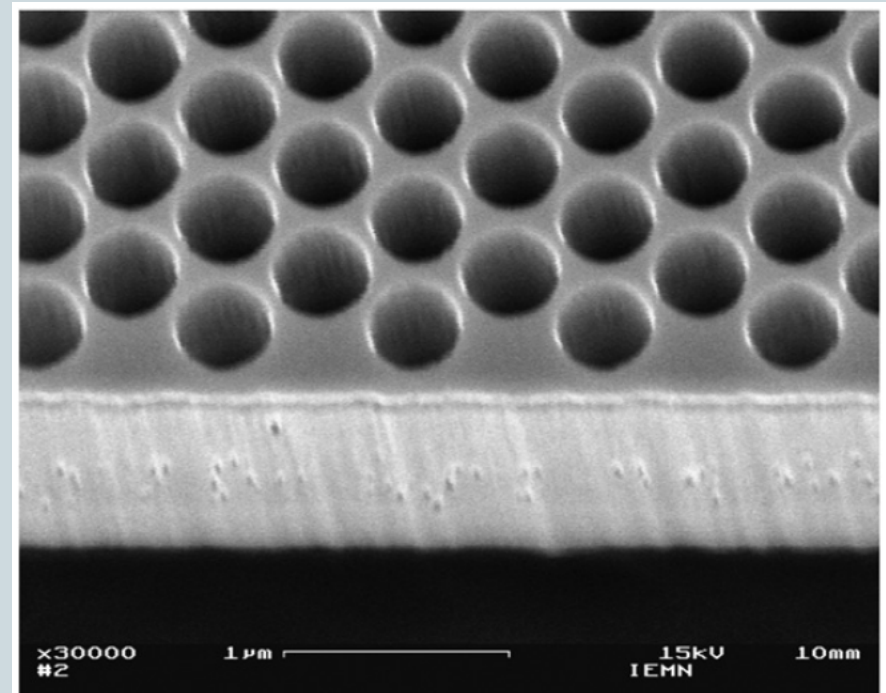
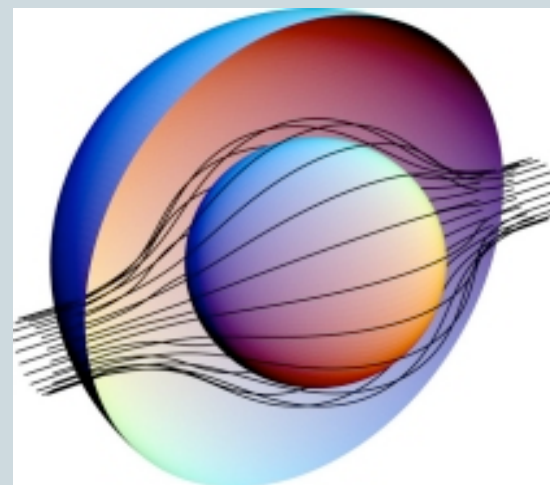
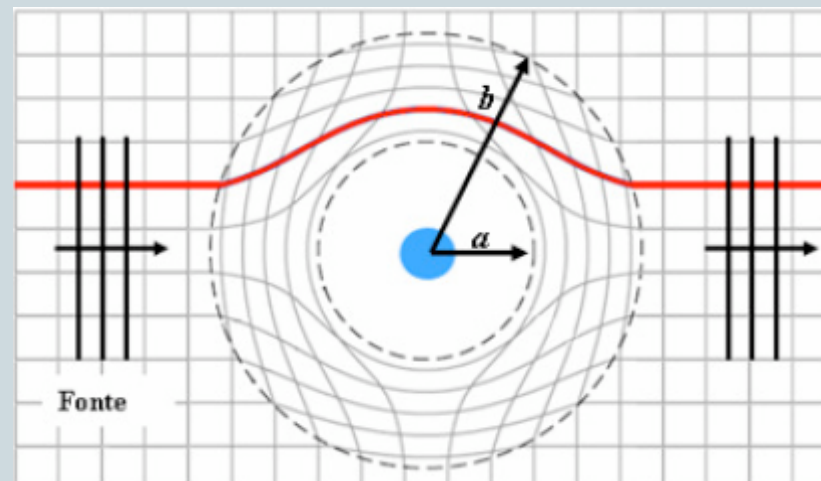
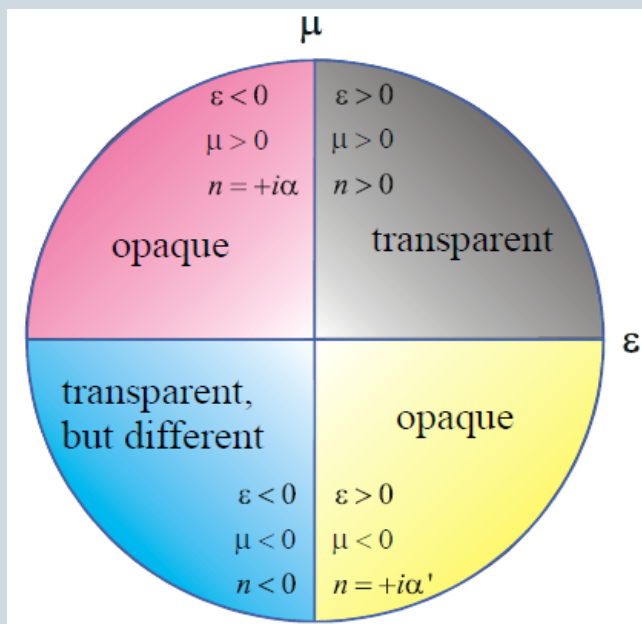


Fig. 15. Close up view of a hole array.

Lippens 2008

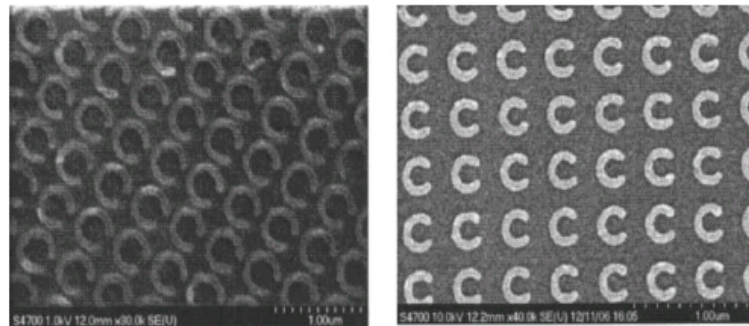
Metamateriais



Uma aplicação: invisibilidade eletromagnética

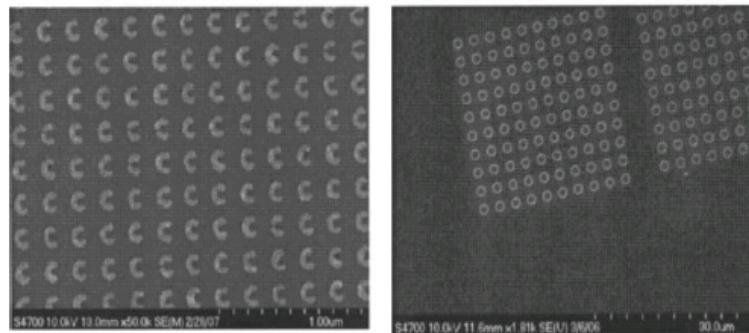
Macedo 2008

Metamaterials



(a)

(b)



(c)

(d)

FIG. 2. Scanning electron micrographs of split ring arrays with radii (a) 215 nm, (b) 130 nm, and (c) 60 nm. (d) Scanning electron micrograph of complete 125 nm radius rings.

Sheridan et al. 2007

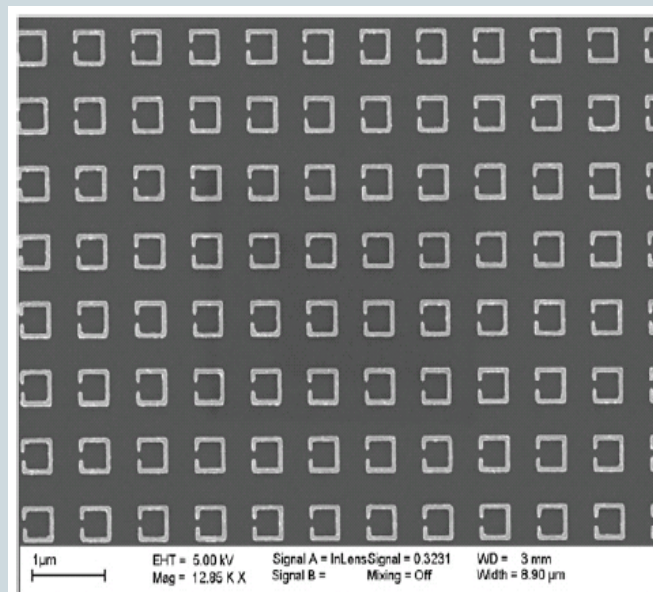
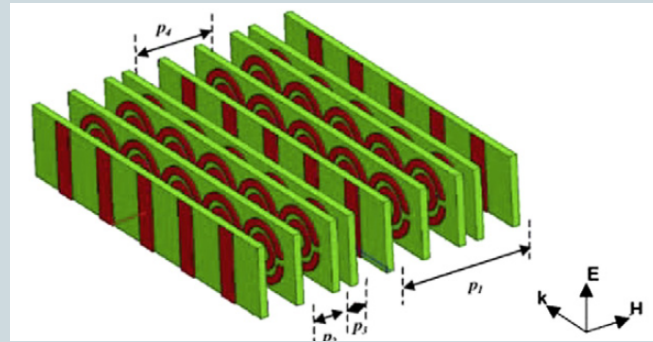


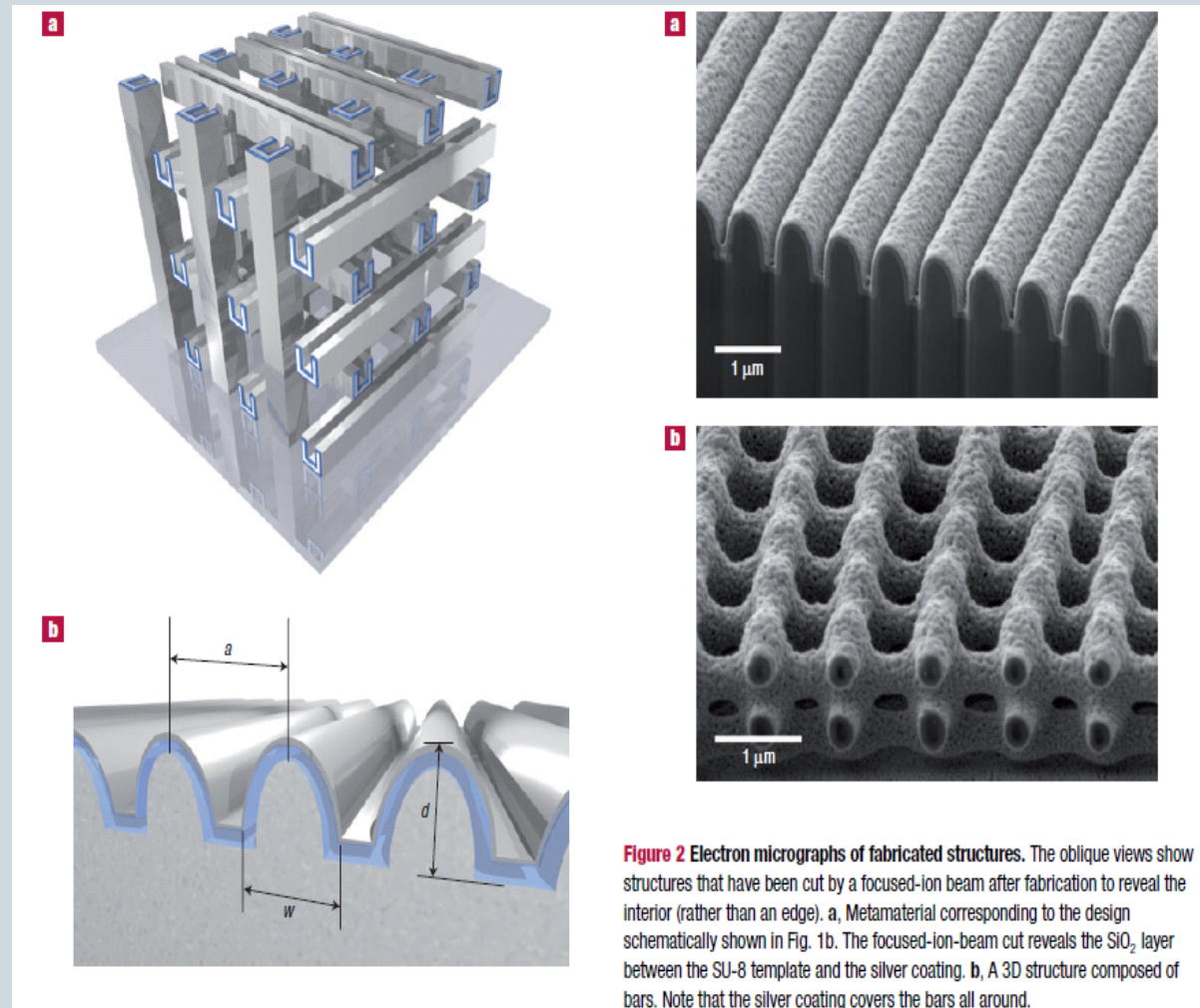
Fig. 11. SEM of a plasmon resonator array.

Lippens 2008

Metamaterials 3D



Michael , S. R. et al. Nature Materials 7 (2008) p. 543-546



Estruturas Quase-periódicas

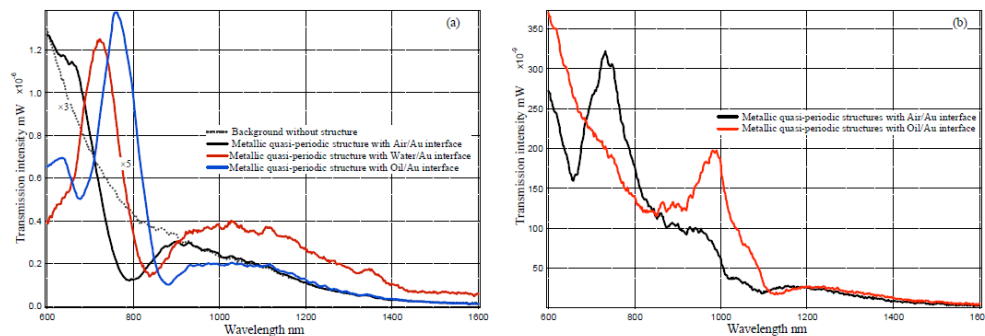


Fig. 3. The transmission spectra of the fabricated metallic quasi-periodic structures. (a) the quasi-periodic structures with three exposures at a rotation angle of 40° (the angle θ is 35°); (b) the quasi-periodic structures with four exposures at a rotation angle of 30° (the angle θ is 22°).

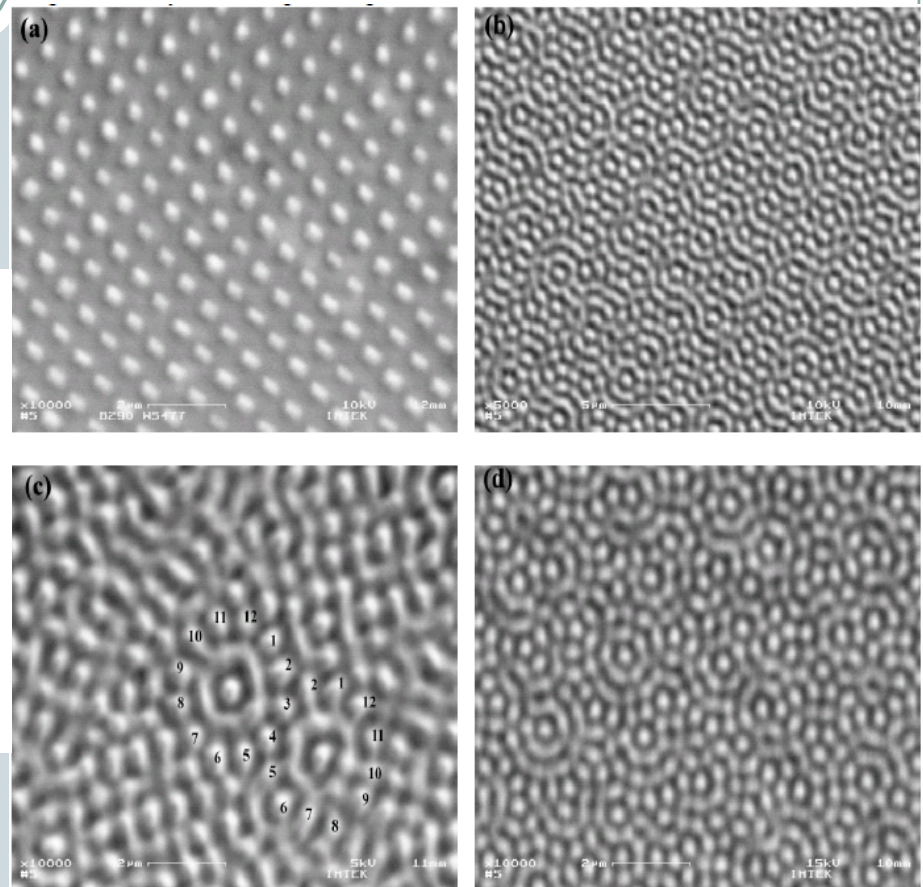


Fig. 2. SEM micrographs of fabricated metallic structures using the exposure wavelength at 442nm, (a),(b)&(c) the angle θ is 22° . (a) the fundamental 2D structures; (b) the quasi-periodic structures with three exposures at a rotation angle of 40° ; (c) the quasi-periodic structures with four exposures at a rotation angle of 30° ; (d) the quasi-periodic structures with three exposures at a rotation angle of 40° (the angle θ is 35°).

Metamaterials Nanoporous

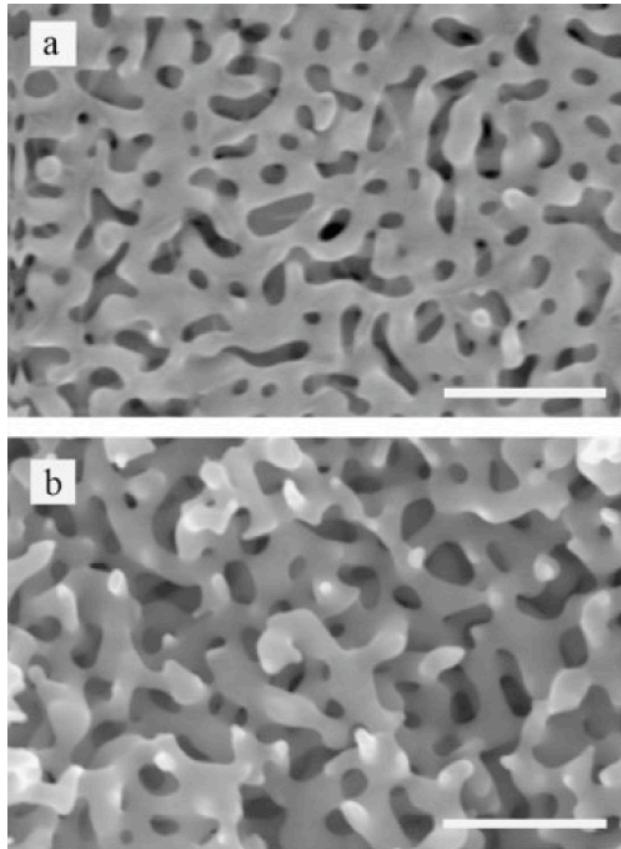


Figure 1. a) Plane-view, and b) cross-sectional scanning electron microscopy (SEM) images showing the characteristic spongelike open-cell foam morphology of np-Au. The material is very homogeneous and exhibits nanometer-sized pores and ligaments, the latter with a length-to-diameter aspect ratio close to one. The scale bars are 300 nm.

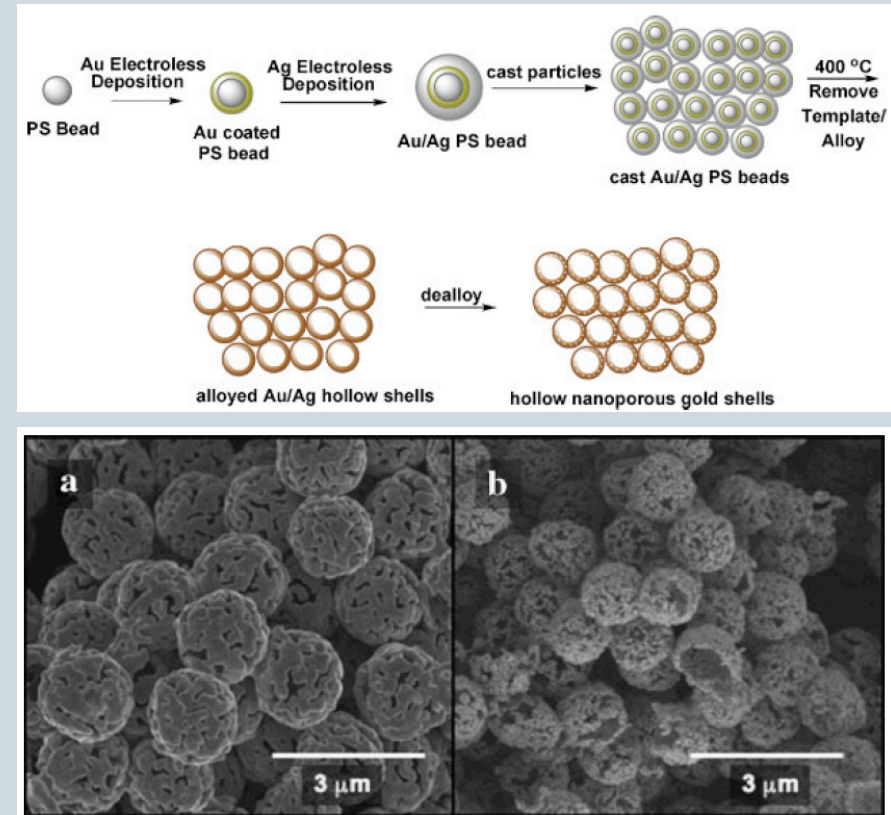


Figure 6. a) Fracture surface of a monolith containing hollow 1 μm $\text{Ag}_{0.7}\text{Au}_{0.3}$ shells before dealloying (density 1 g cm^{-3}). b) Fracture surface of a monolith containing hollow 1 μm nanoporous Au shells after dealloying (density 0.45 g cm^{-3} or 2.3% of the full density of Au).

Biener et al. 2008

Materiais Massivos Nanoestruturados

24

- Definição

- Materiais monofásicos ou multifásicos organizados em unidades entre 1 e 200 nm

- Motivação

- A grande densidade de contornos de grão altera significativamente:

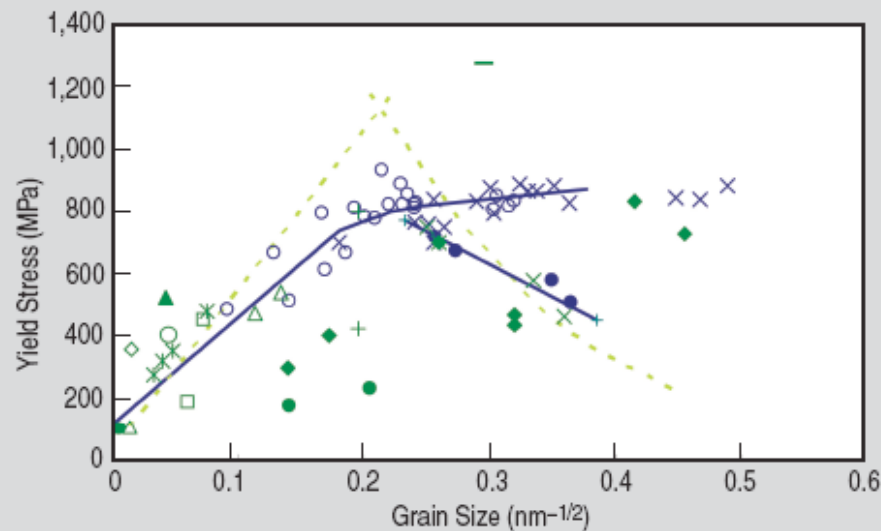
- ✦ limite de escoamento
- ✦ módulo de elasticidade
- ✦ ductilidade
- ✦ tenacidade
- ✦ resistência à fadiga
- ✦ resistência à fluência

Equação de Hall-Petch

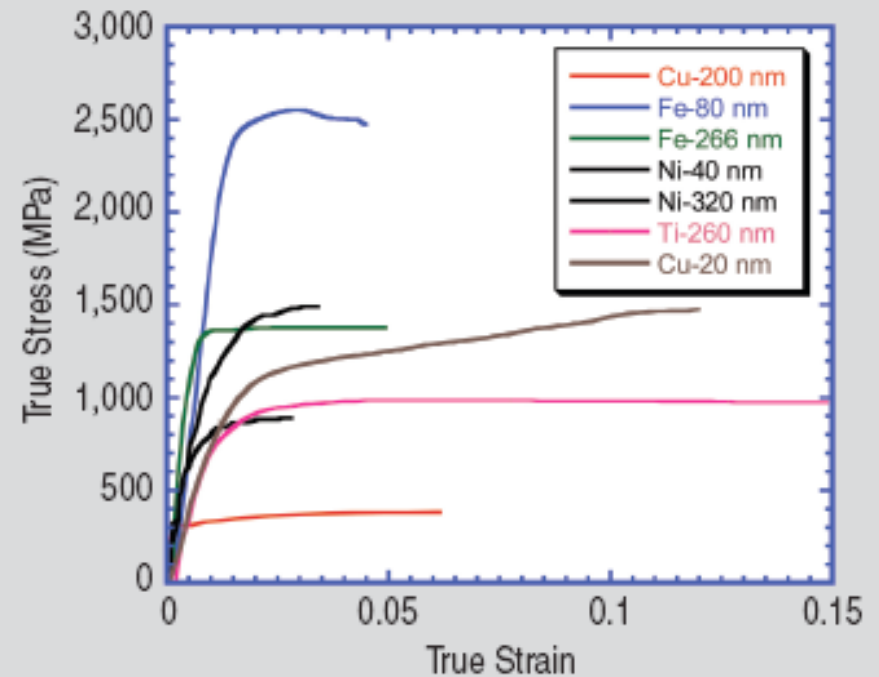
$$\sigma_{esc} = \sigma_o + K_e (d)^{-n}$$

n é tradicionalmente 1/2

Propriedades



Limite de Escoamento do Cobre



Curva Tensão x Deformação compressiva

Meyers et al, JOM, Abril (2006) p. 41-48

Controle Nanoestrutural

26

- **Processamento**

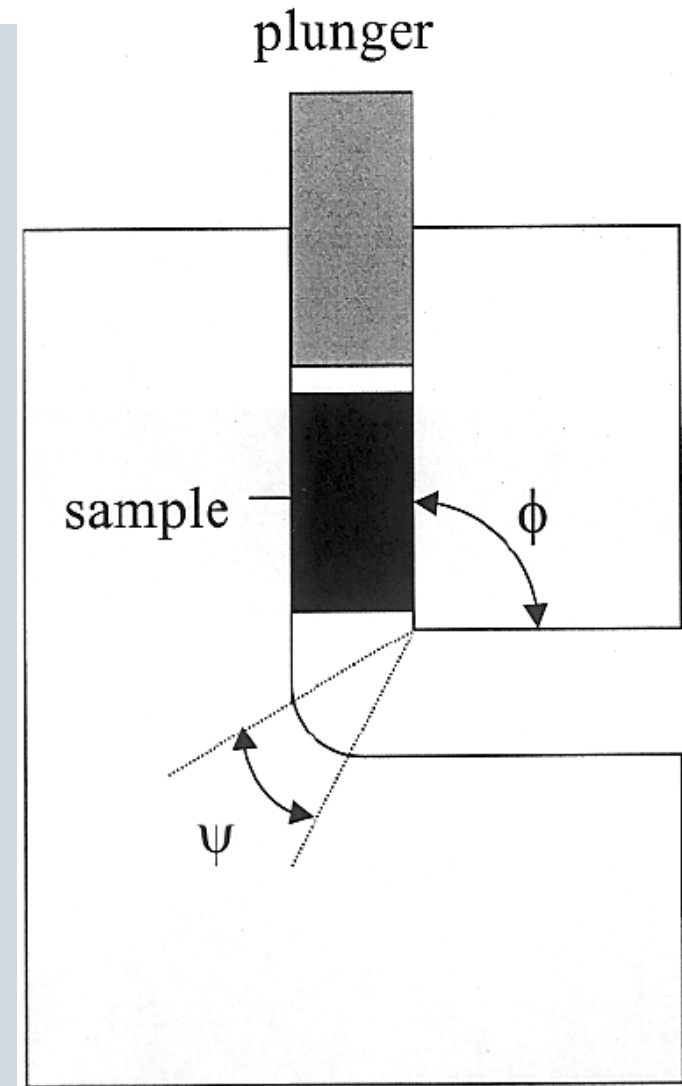
- Métodos “Botton-up”

- ✦ Técnicas de deposição
- ✦ Técnicas de compactação

- Métodos “Top-down”

- ✦ “Torsion straining under High Pressure” (HPT)
- ✦ “Equal Channel Angular Pressing” (ECAP)

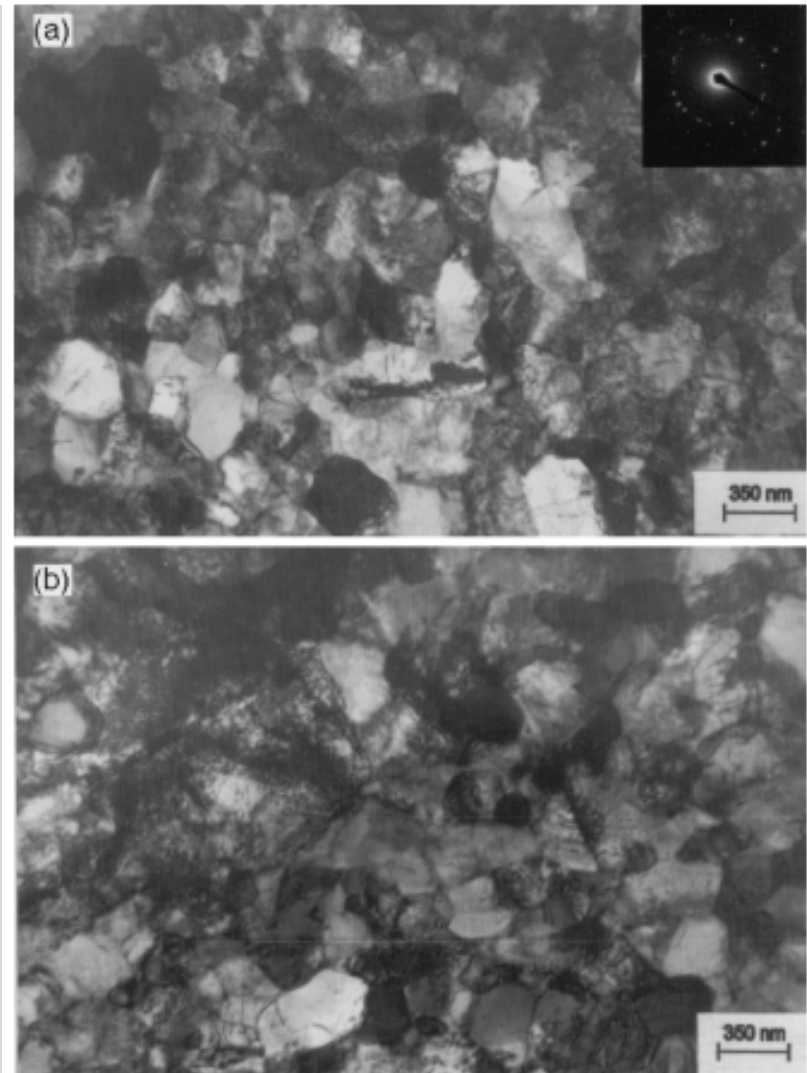
Segal, V. M. Mat. Sci. Eng. A197 (1995) p. 157-164
Park, K-T et al. Mat. Sci Eng. A293 (2000) p. 165-172



Ti com Grão Ultrafino

27

- Rota B_C
- Grãos equiaxiais
- TG ~ 260 nm



Stolyarov, V.V. et al. Mat Sci
Eng A299 (2001) p. 59-67

Estratégias para contornar a ausência de encruamento

28

○ Distribuição bimodal de TG

A – Cu recristalizado

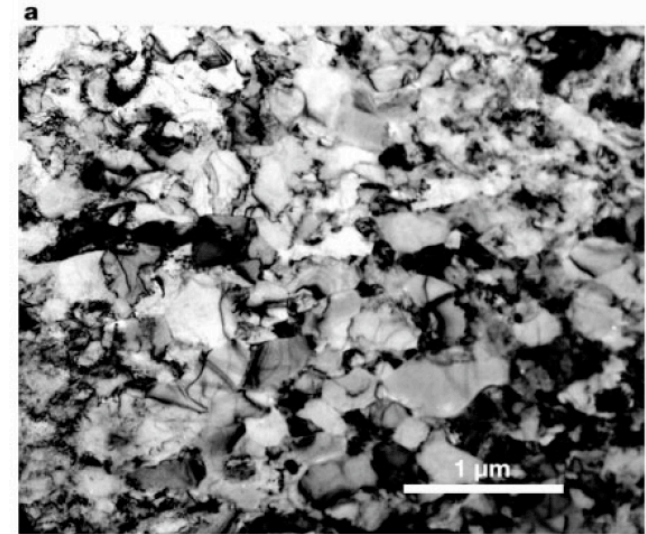
B – Cu deformado 95%

C – Cu deformado 93% N Liq

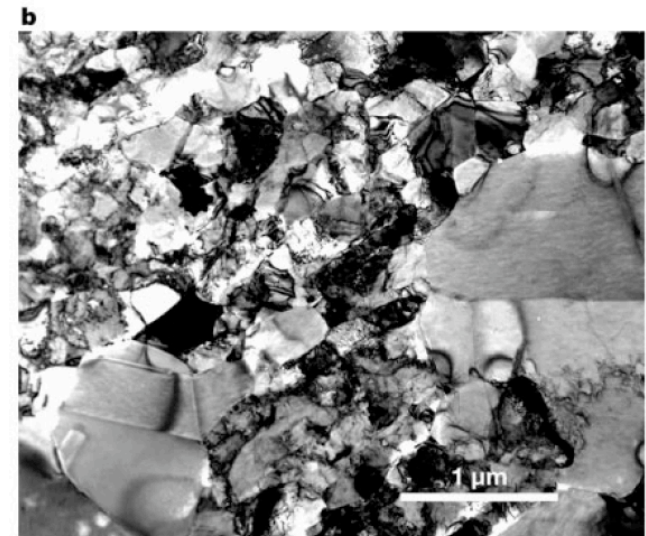
D – C + 180°C / 3 min

E – C + 200°C / 3 min

D



E



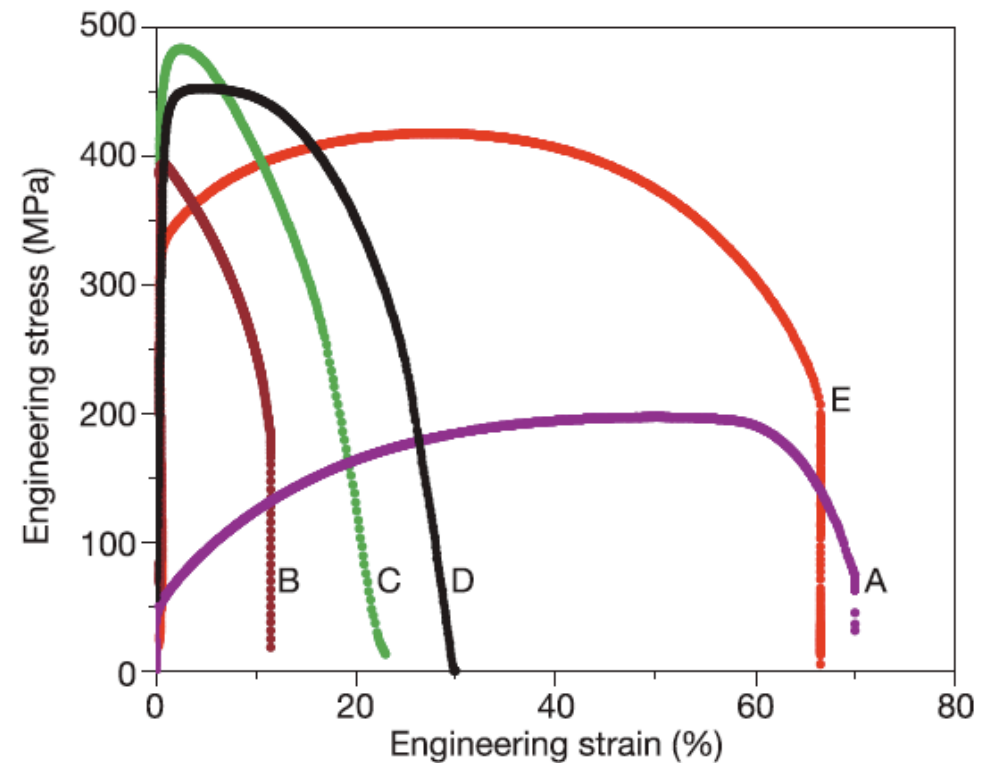
Wang, Y et al, Nature, V. 419/31 (2006) p. 912-915

Estratégias para contornar a ausência de encruamento

29

○ Distribuição bimodal de TG

- A – Cu recristalizado
- B – Cu deformado 95%
- C – Cu deformado 93% N Liq
- D – C + 180°C / 3 min
- E – C + 200°C / 3 min

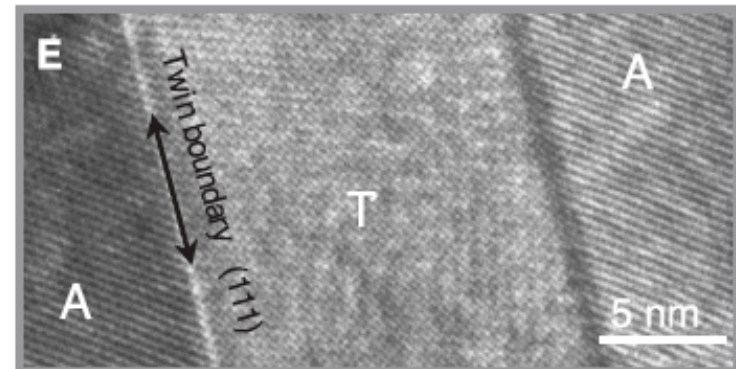
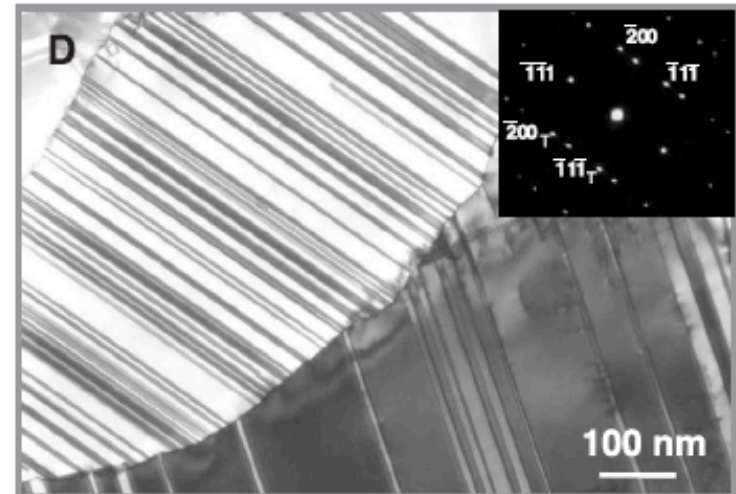
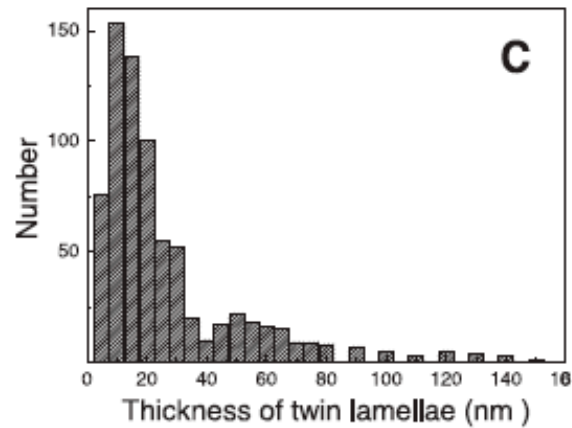
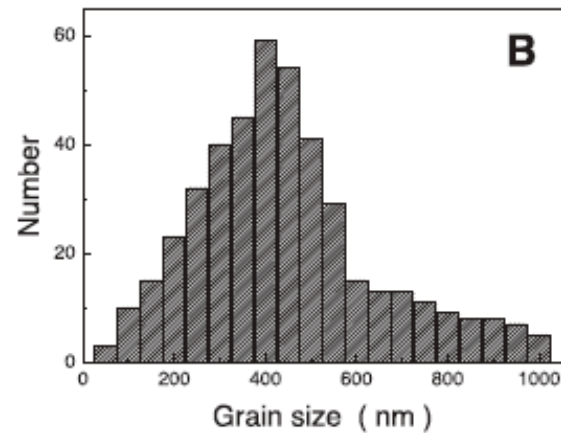
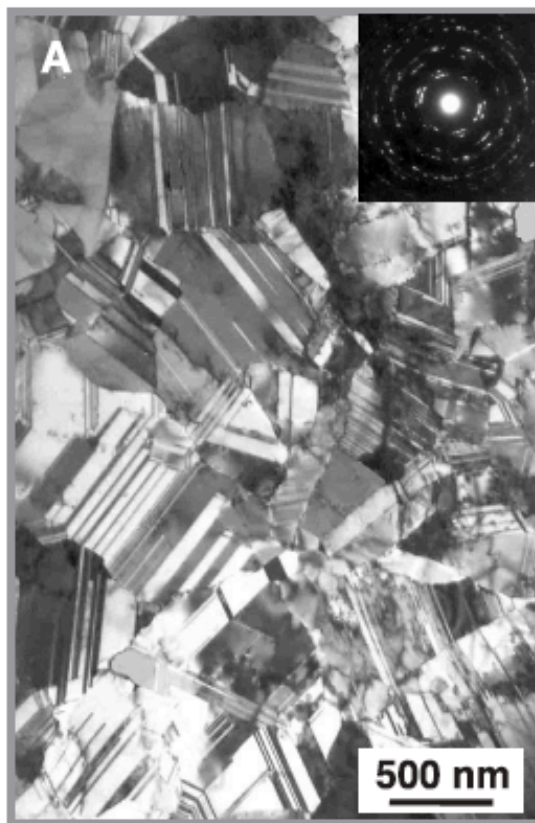


Wang, Y et al, Nature, V. 419/31 (2006) p. 912-915

Estratégias para contornar a ausência de encruamento

30

○ Nanomaclas



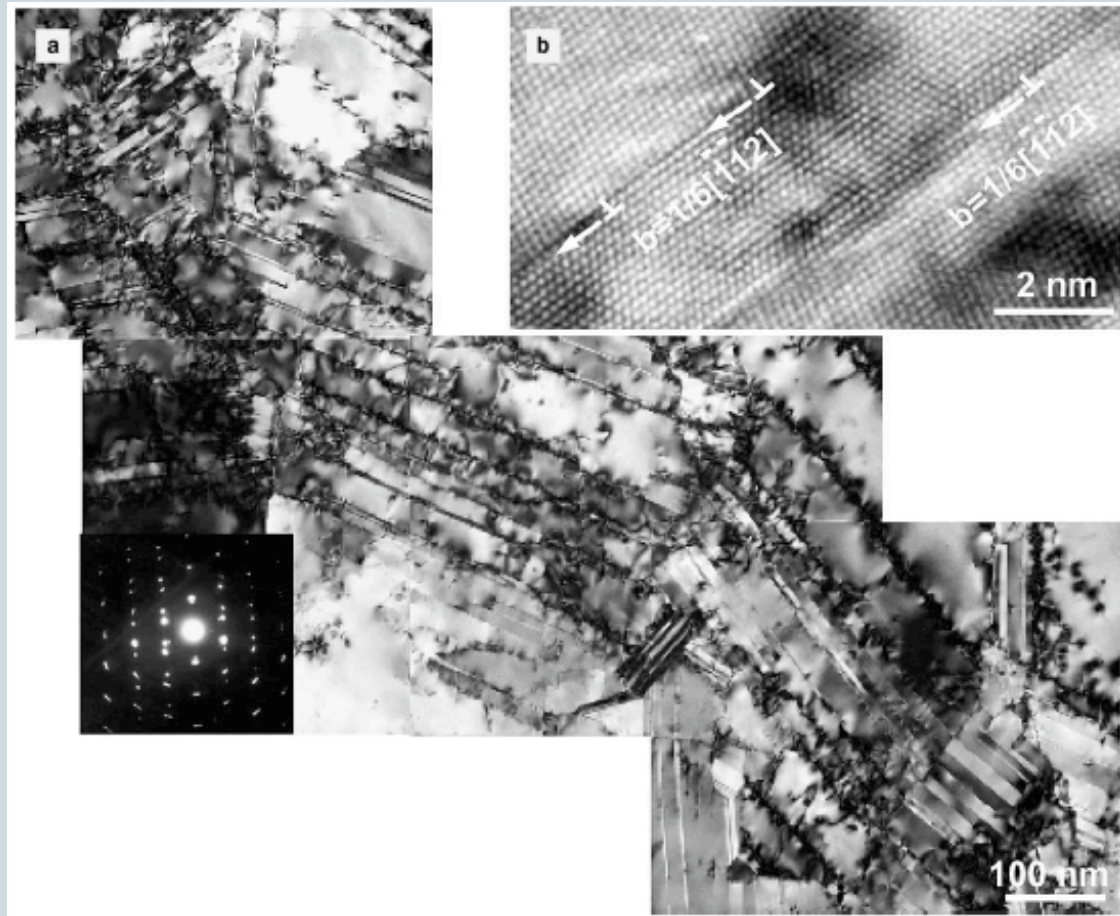
Lu, L. et al, Science, V. 304 (2004) p. 422-426

Estratégias para contornar a ausência de encruamento

31

○ Nanomaclas

Maclas são efetivas no bloqueio do movimento das discordâncias.

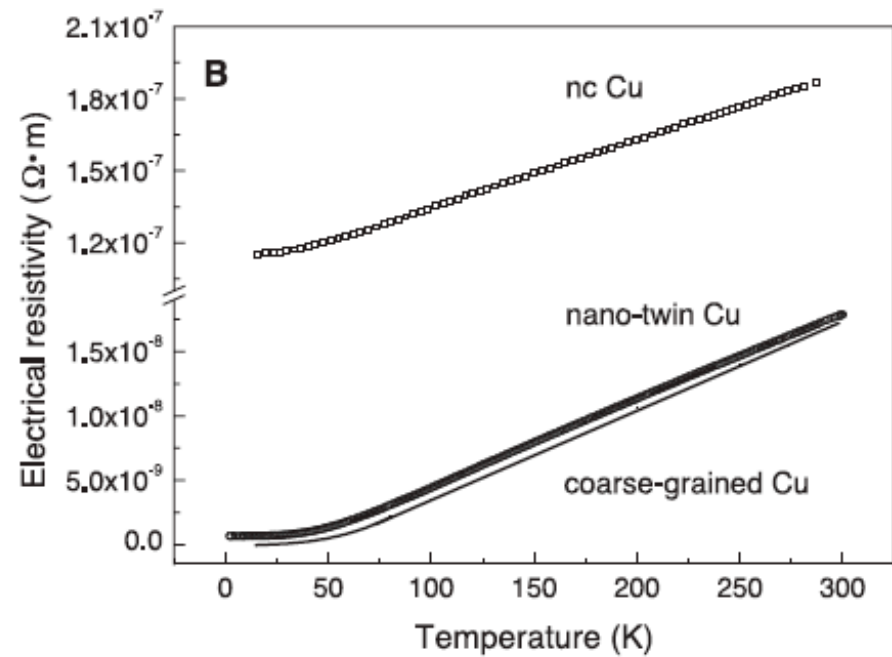
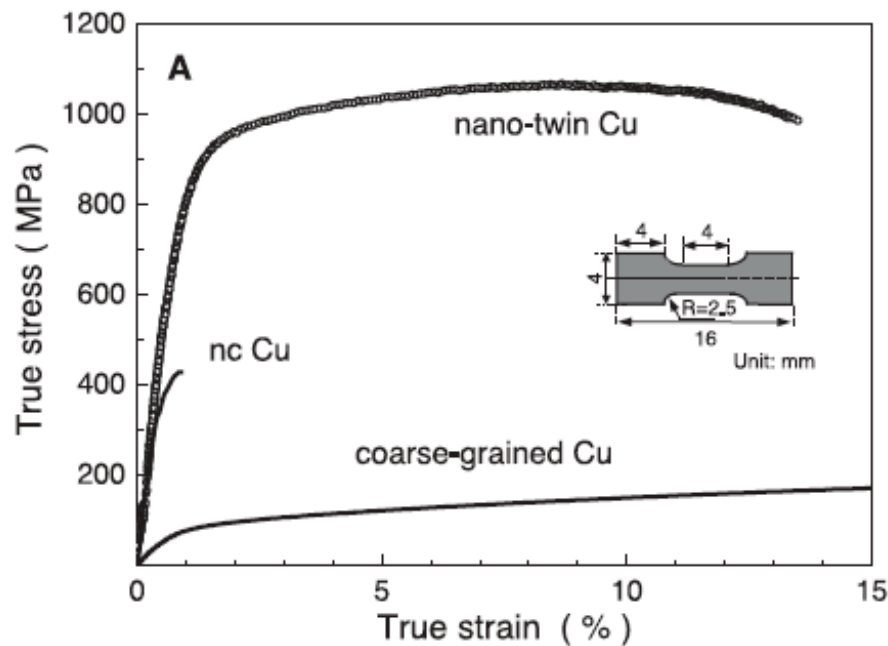


Shen, Y. F. et al, Scripta Mater, V. 52 (2005) p. 989-994

Estratégias para contornar a ausência de encruamento

32

○ Nanomaclas

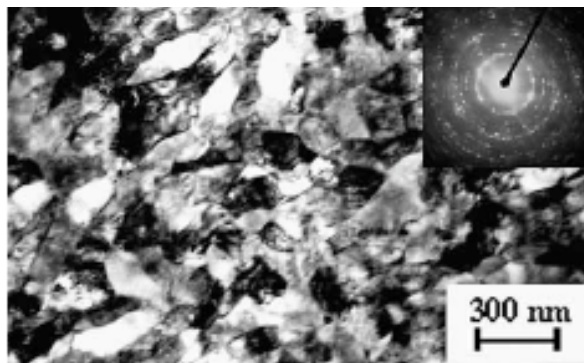


Lu, L. et al, Science, V. 304 (2004) p. 422-426

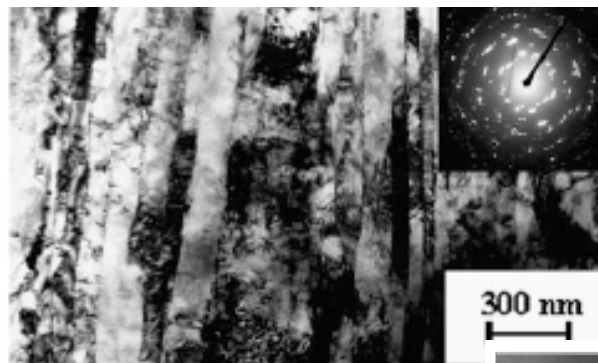
Ti Nanocristalino como Biomaterial

33

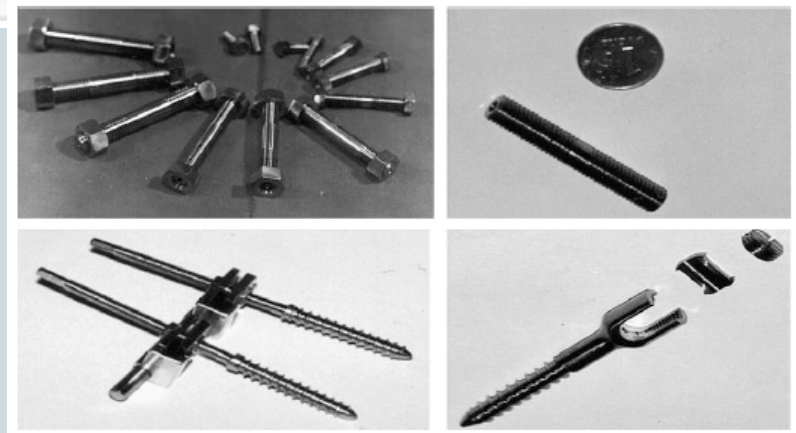
State	UTS (MPa)	YS (MPa)	A (%)	Z (%)
Initial	440	370	38	60
ECAP, 4 passes	630	545	22	51
ECAP, 4 passes + TMT $\varepsilon = 60\%$	1030	845	12	51
ECAP, 4 passes + TMT $\varepsilon = 80\%$	1150	1100	11	56



Seção transversal



Seção longitudinal

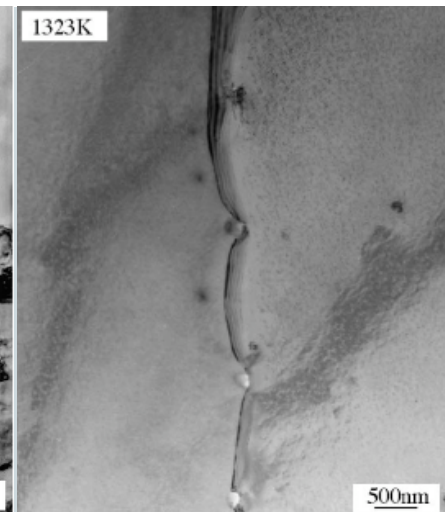
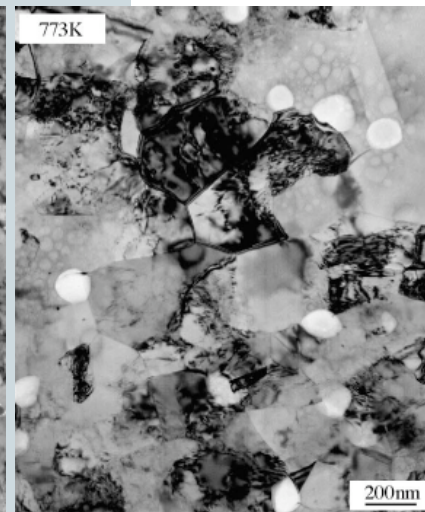
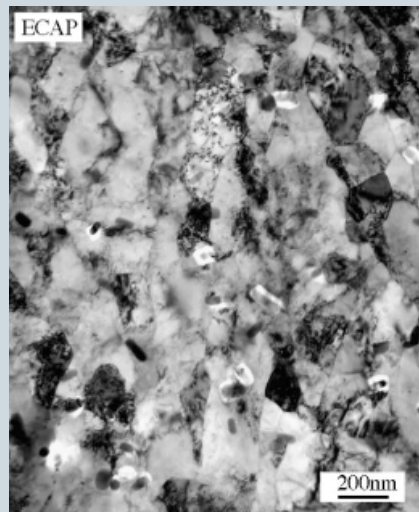
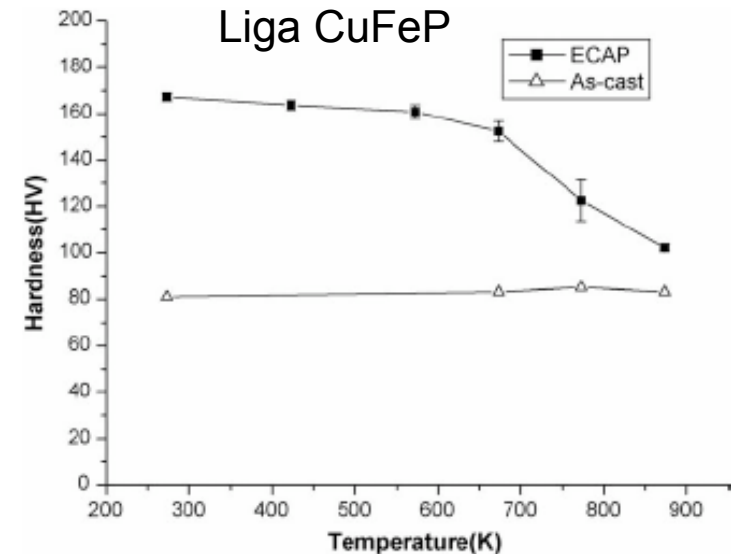


Latysh, , V. et al, Current Applied Physics
V.6 (2006) p. 262-266

Controle Nanoestrutural

34

- Estabilização da estrutura
 - Abordagem cinética
 - ✦ Contornos de grão têm sua mobilidade reduzida por arraste de segunda fase e soluto.
 - Abordagem termodinâmica

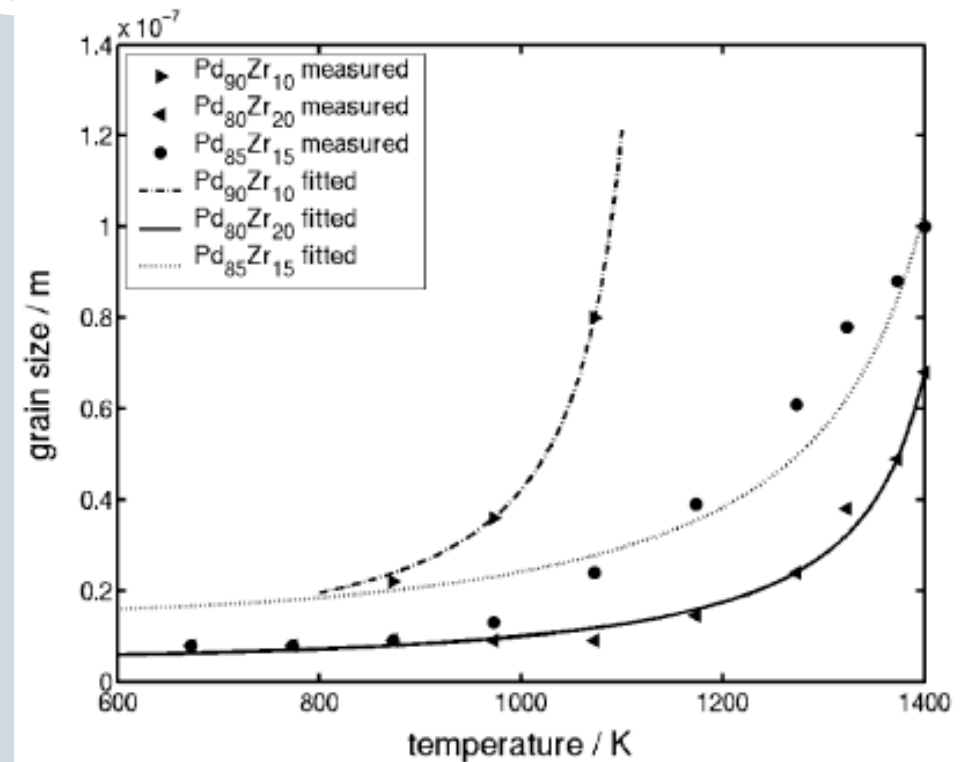


Cao, H. et al. Mat. Sci. Eng. A431 (2006) p. 86-91

Controle Nanoestrutural

35

- Estabilização da estrutura
 - Abordagem cinética
 - Abordagem termodinâmica
 - ✧ Força motriz para o crescimento de grão é reduzida pela redução da energia do contorno de grão através da saturação do mesmo.



TG saturado

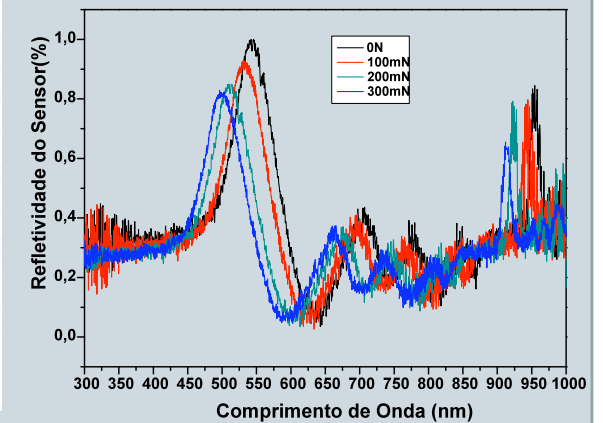
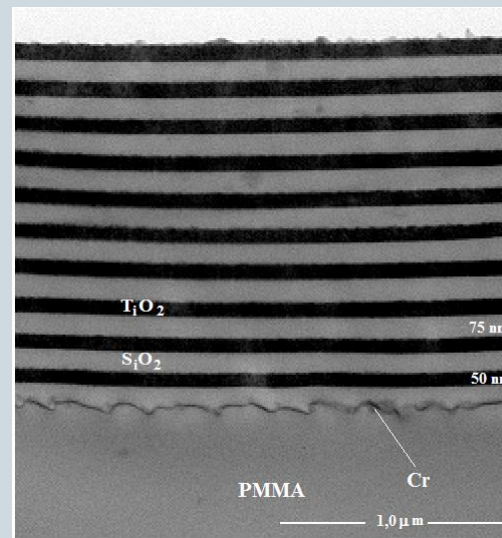
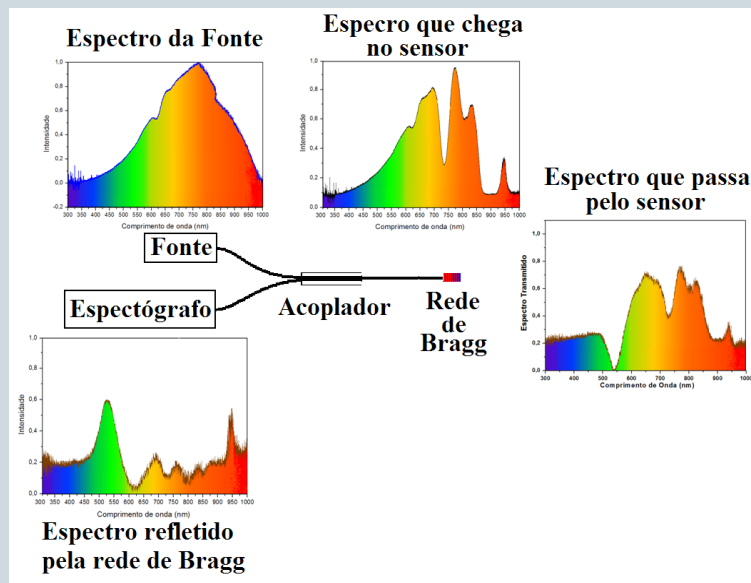
$$D = \frac{3\Gamma_{b0}V_M}{X_{\text{total}} - \exp\left(\frac{\sigma_0 - \Gamma_{b0}\Delta H_{\text{seg}}}{\Gamma_{b0}RT}\right)}$$

Liu e Kirchheim, Scr. Mater. 51 (2004) p. 521-525

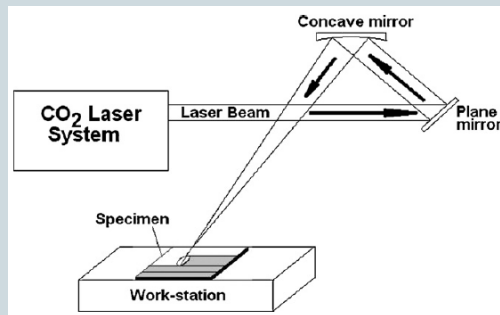
Sensores de Bragg



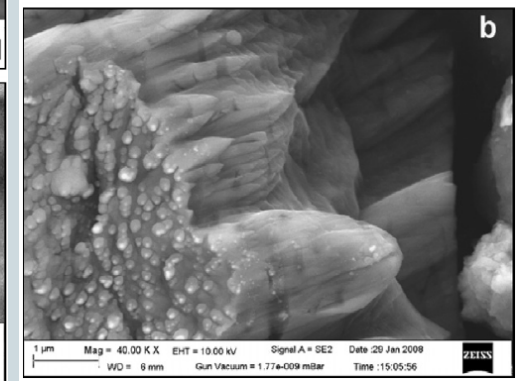
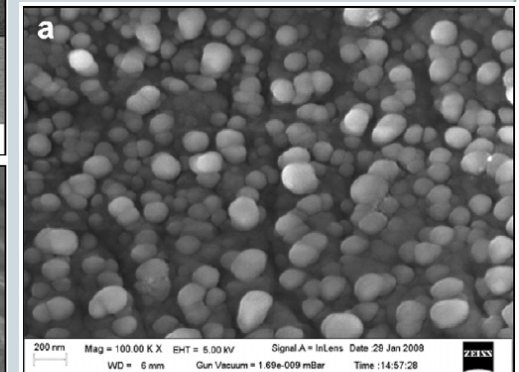
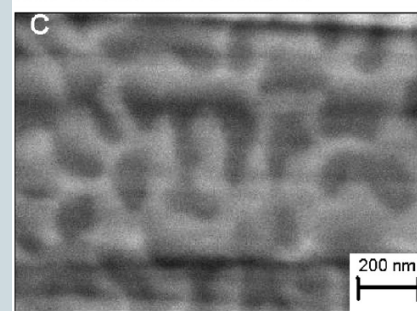
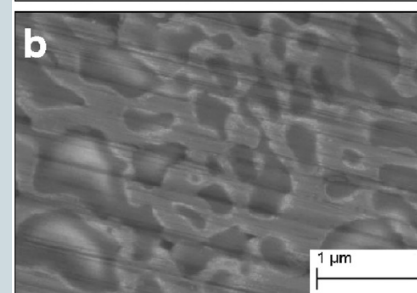
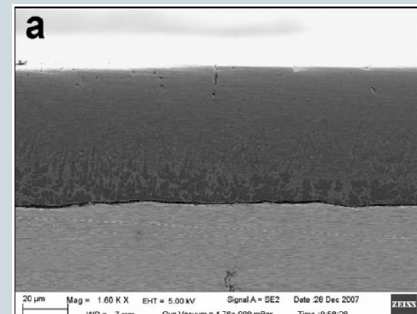
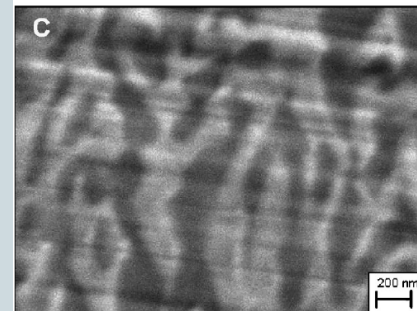
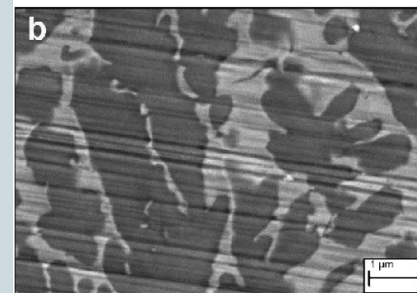
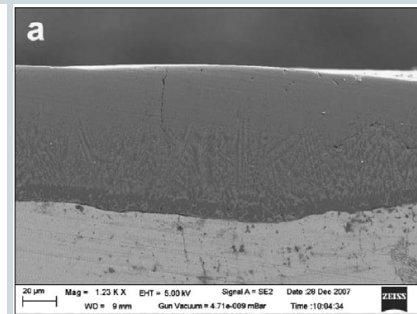
- Redes de Bragg em POF
 - Sensores na ponta de POF através de redes de Bragg constituídas de multicamadas de óxidos com diferentes índices de refração



Revestimento Cerâmico Nanoestruturado Multicomponente



Pó de Al, TiO_2 e B_4C colocado sobre a superfície;
sinterização SHS (self-propagating high temperature synthesis) proporcionada pelo feixe de laser



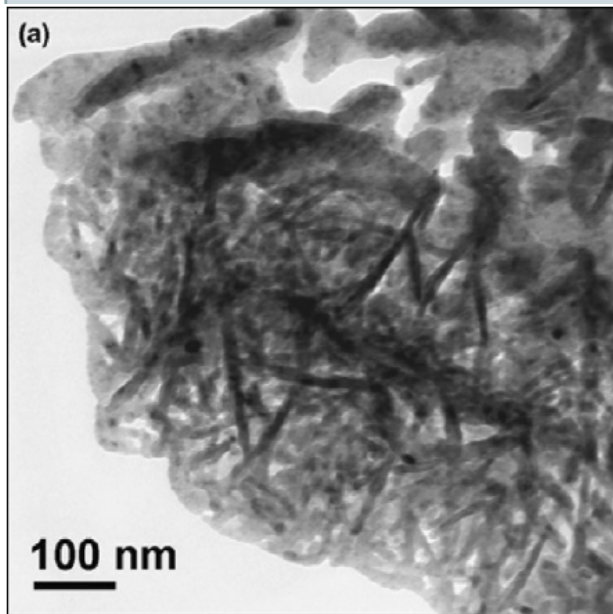
Masanta et al. (2009)

2,5 kW a 2,5 mm/s

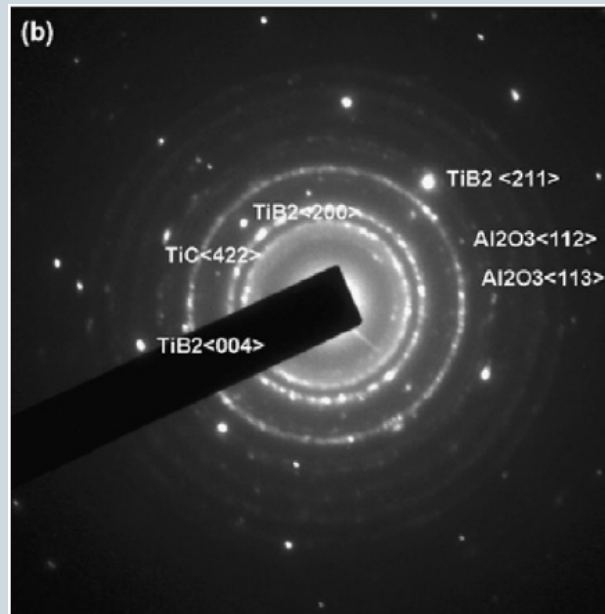
2,5 kW a 5 mm/s

2,5 kW a 10 mm/s

Revestimento Cerâmico Nanoestruturado Multicomponente

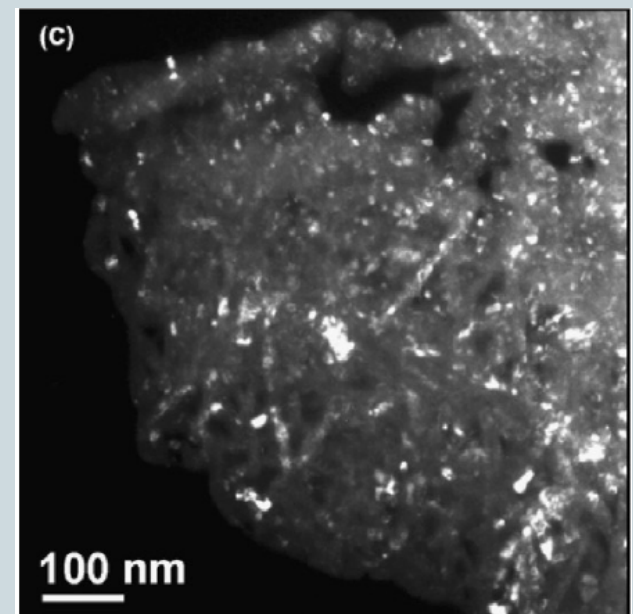


Campo claro



SAD

2,5 kW a 10 mm/s
Masanta et al. (2009)

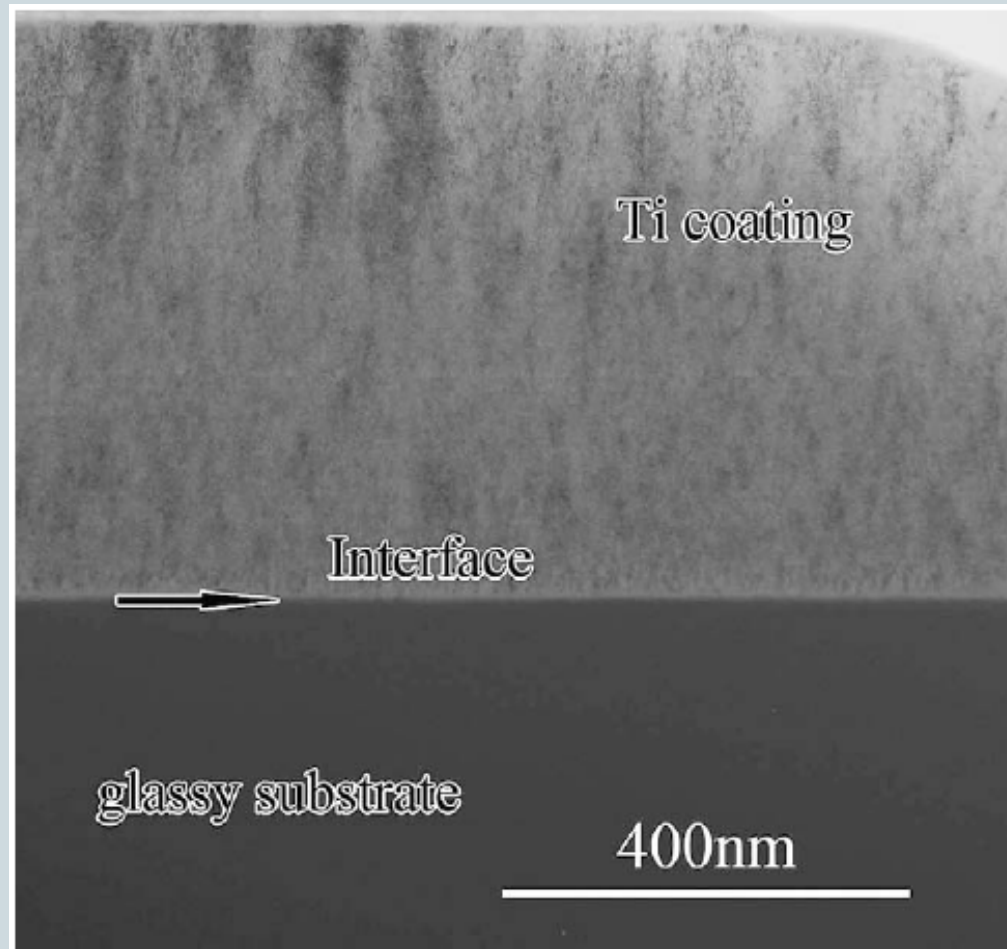


Campo escuro com o
spot de TiB_2

Revestimento de Ti sobre Vidro Metálico $\text{Zr}_{10}\text{Al}_5\text{Ni}_{30}\text{Cu}$

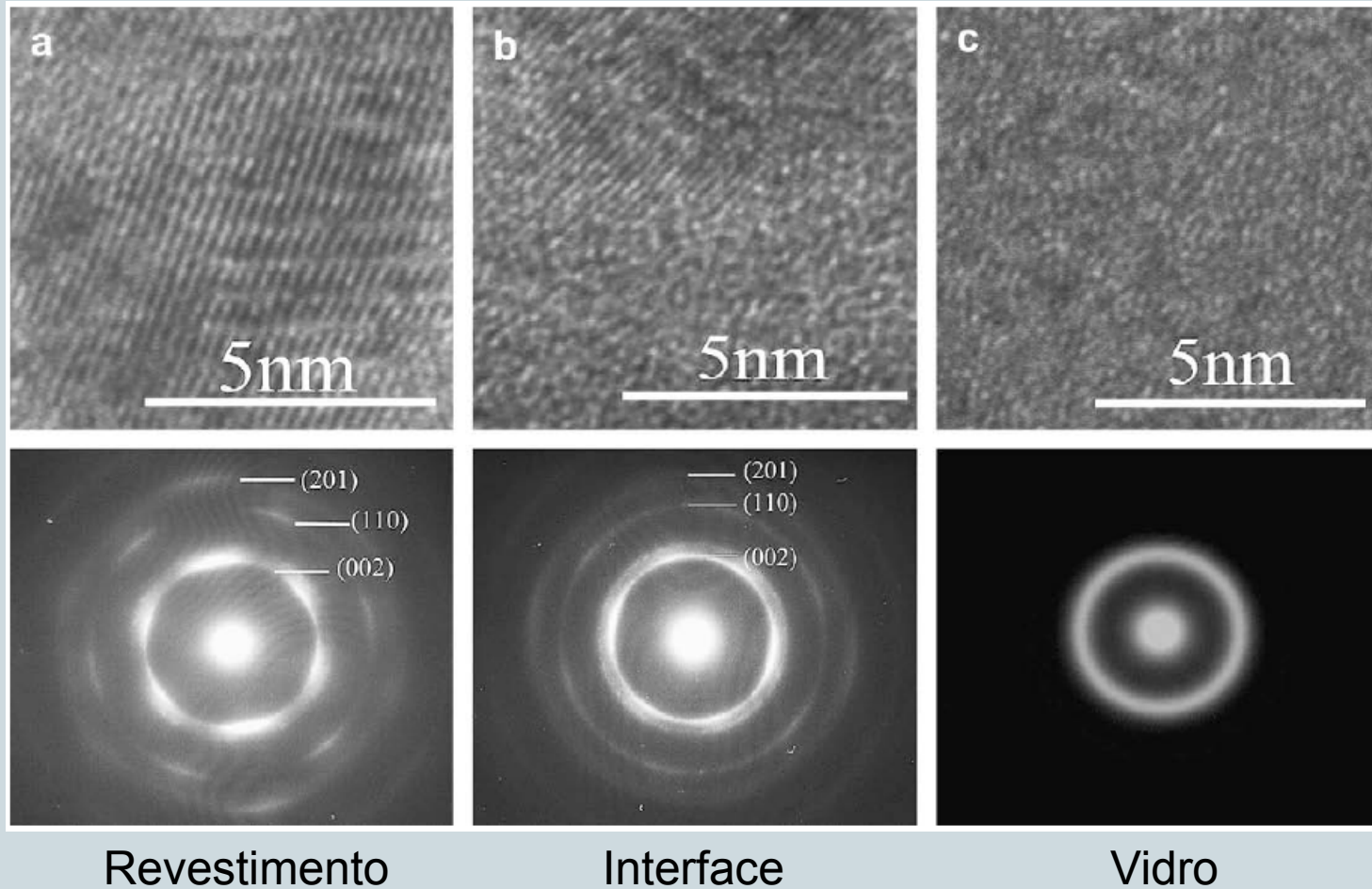


Deposição por
sputtering a 200°C



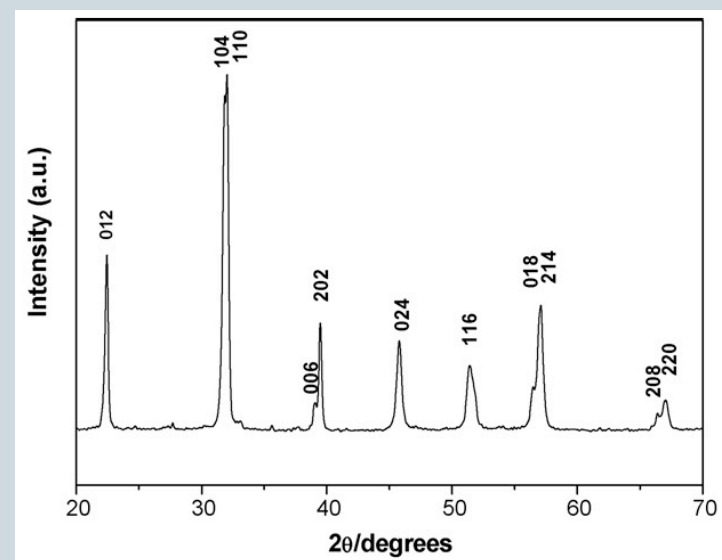
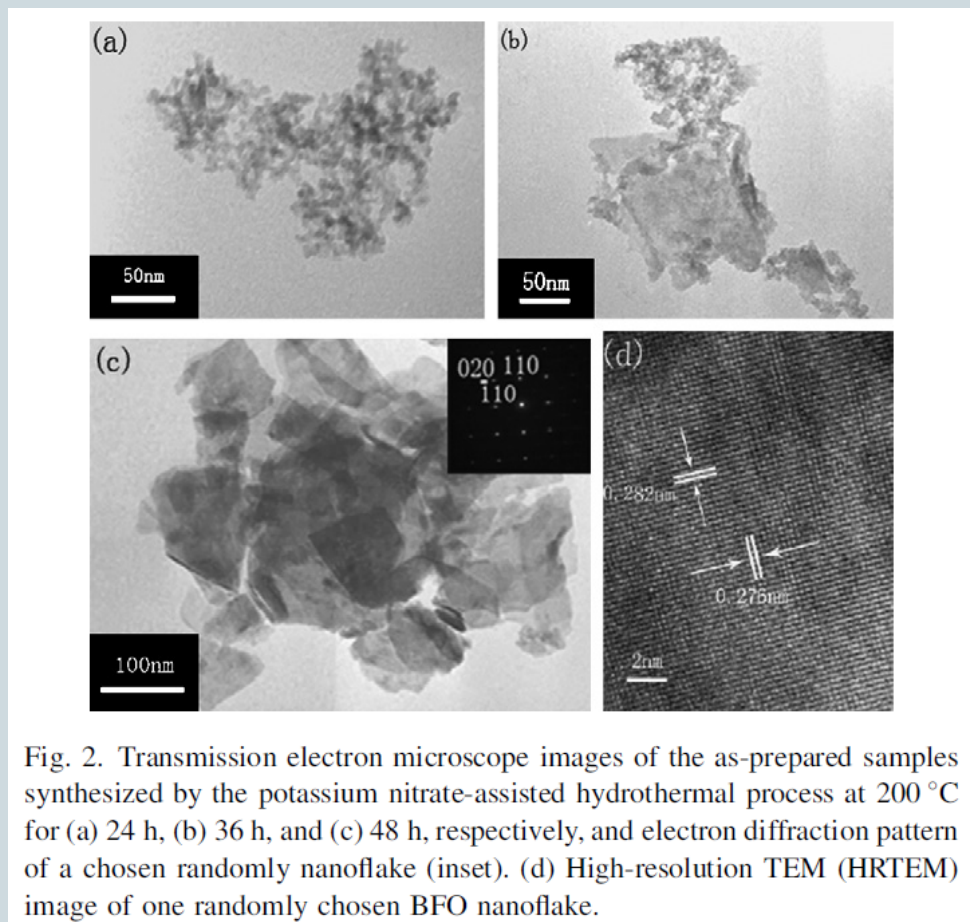
Qin et al. 2009

Revestimento de Ti sobre Vidro Metálico $\text{Zr}_{10}\text{Al}_5\text{Ni}_{30}\text{Cu}$



Qin et al. 2009

Multiferróicos – BiFeO_3



Wang et al. 2009

Multiferróicos – BiFeO_3

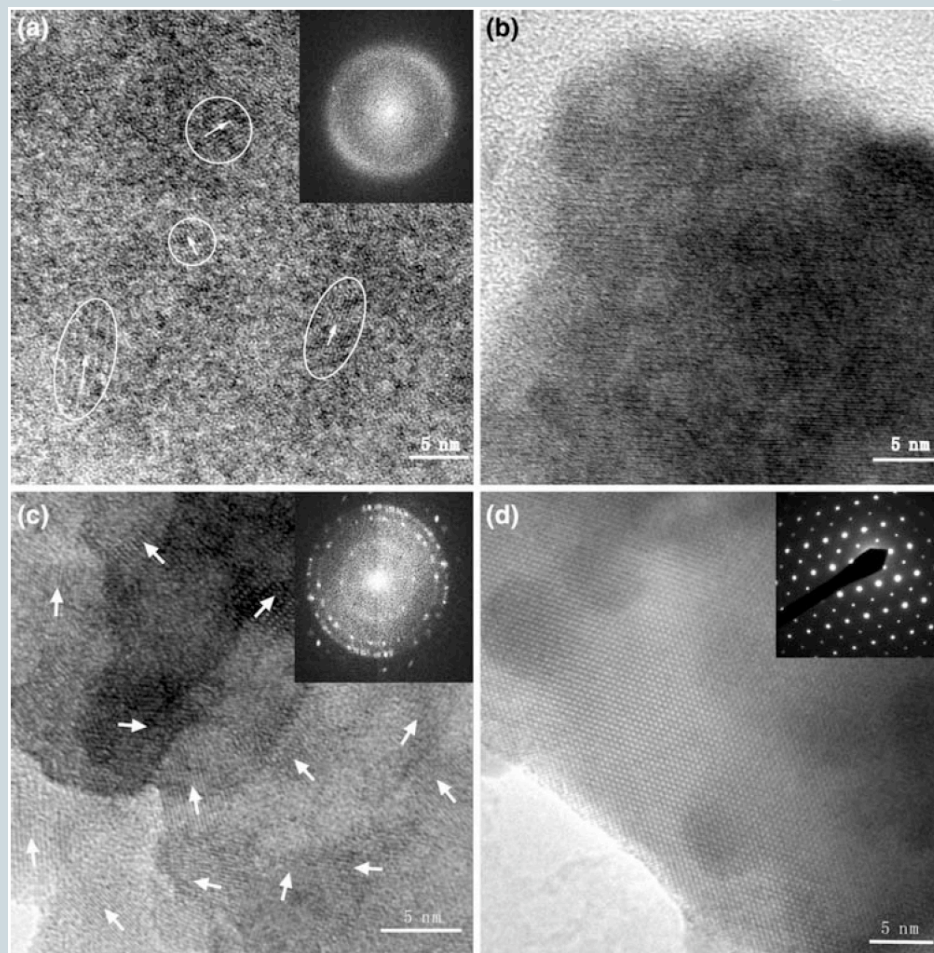
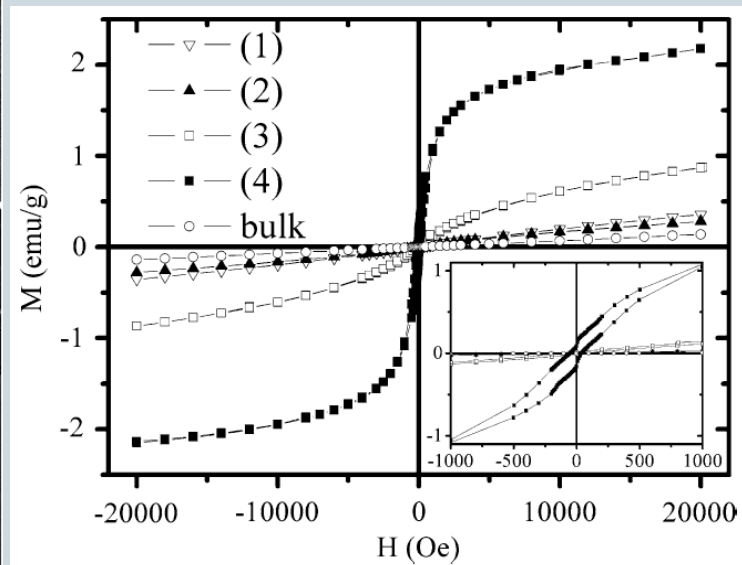


Fig. 3 HRTEM image and the corresponding electron diffraction patterns of (1) (a, b), (3) (c) and (4) (d). The *arrows* indicate the direction of crystals



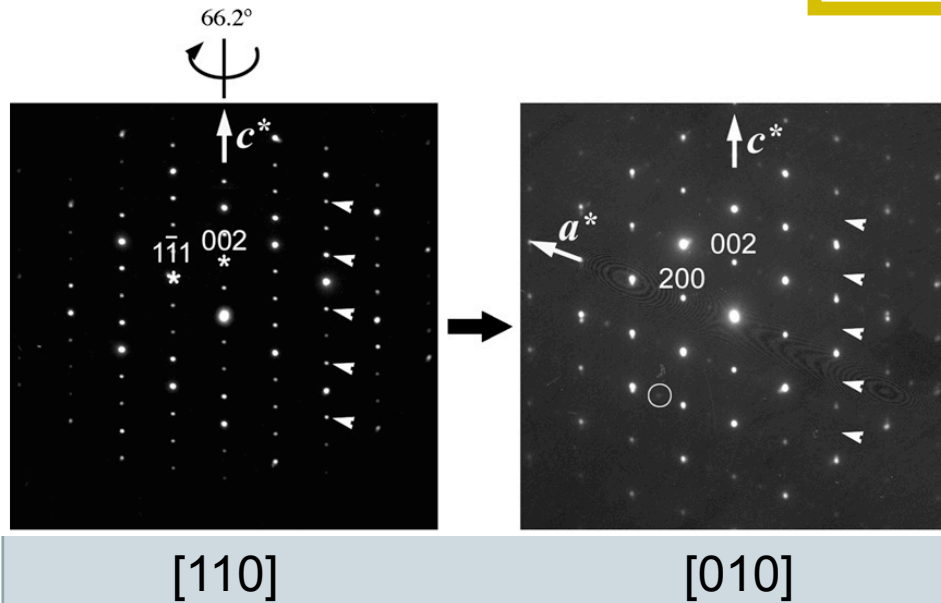
BiFeO_3 sintetizado por sol-gel com aquecimento por microondas.

Luo et al. 2009

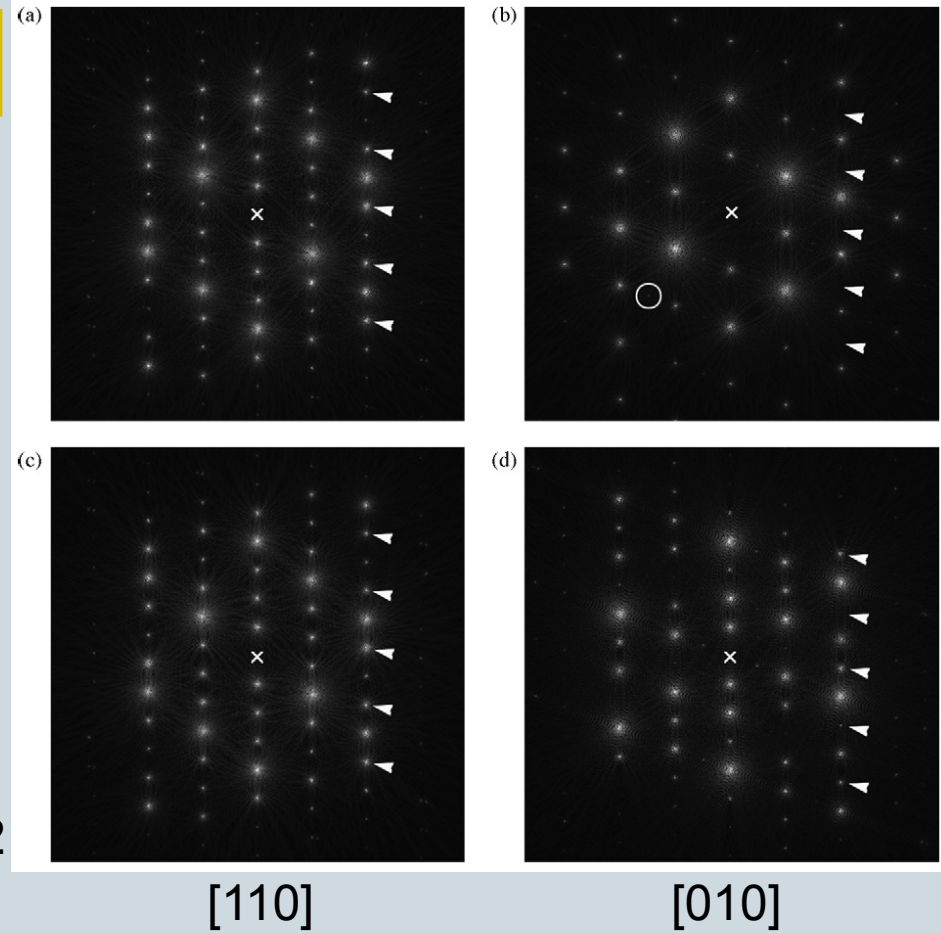
Multiferróicos – BiMnO_3



C2/c



C2



Yang et al. 2008

Padrão de difração calculado

Multiferroicos – BiMnO_3

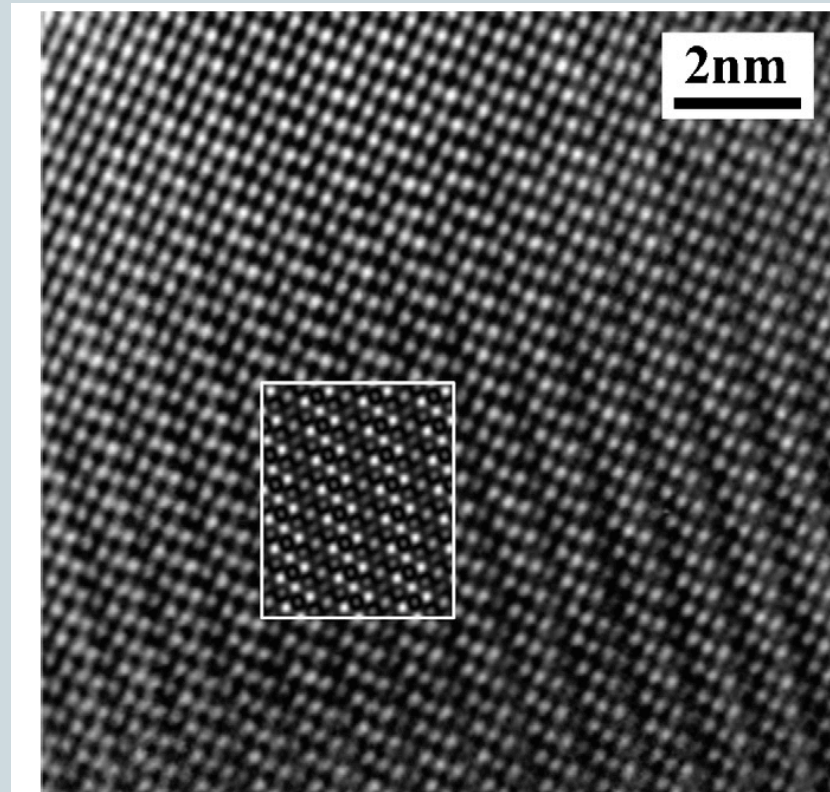
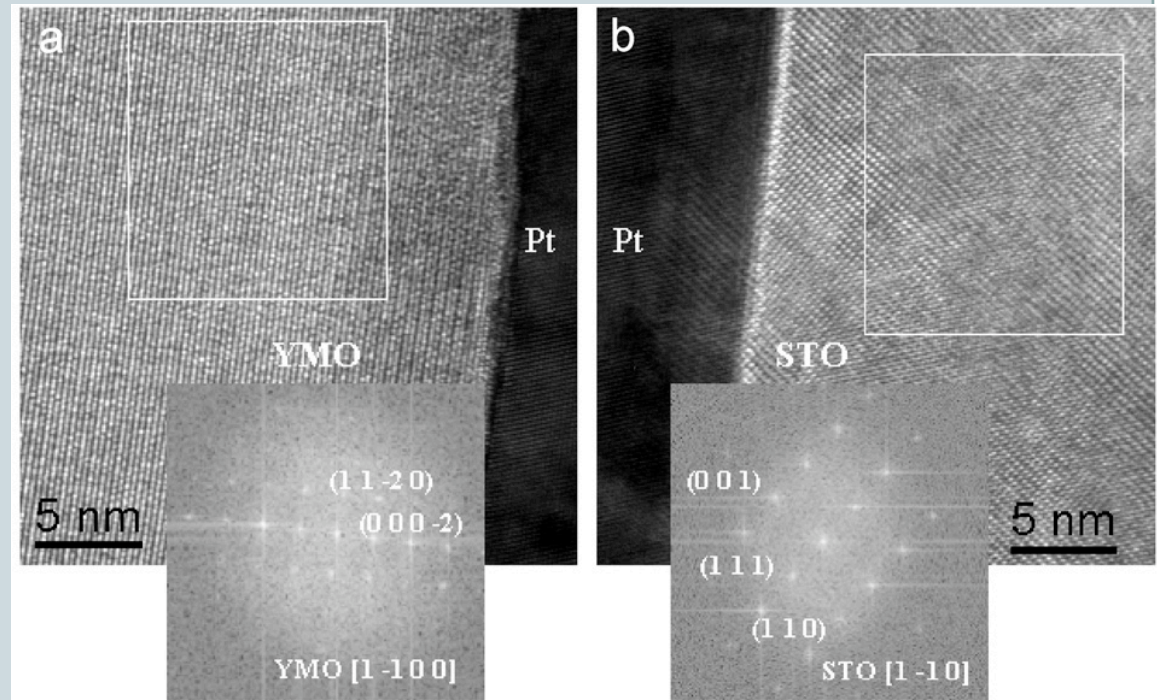
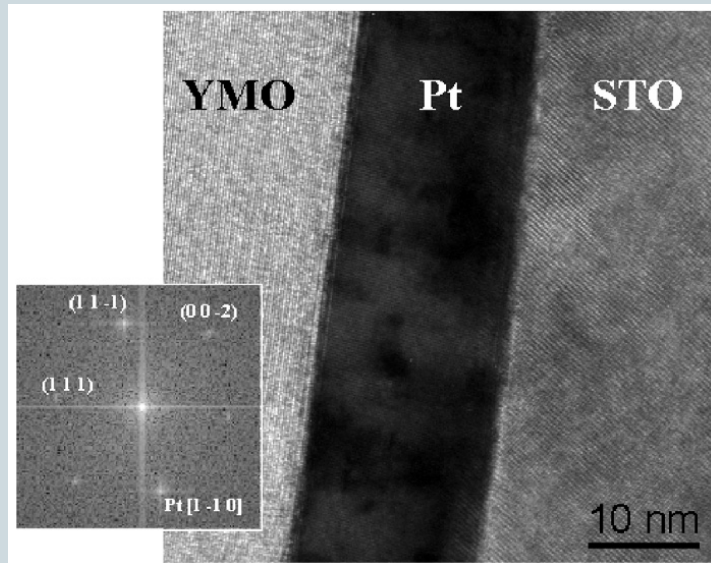


Fig. 5. $[1\ 1\ 0]$ HRTEM image taken under the defocus value of approximately -70 nm . A simulated image for a thickness of 15.4 nm and a defocus value of -70 nm is superimposed onto the experimental image to produce the good agreement.

Yang et al. 2008

Epitaxia no Crescimento de YMnO_3 sobre Pt e SrTiO_3



$\text{YMO (0001)} // \text{Pt (111)} // \text{STO (111)}$

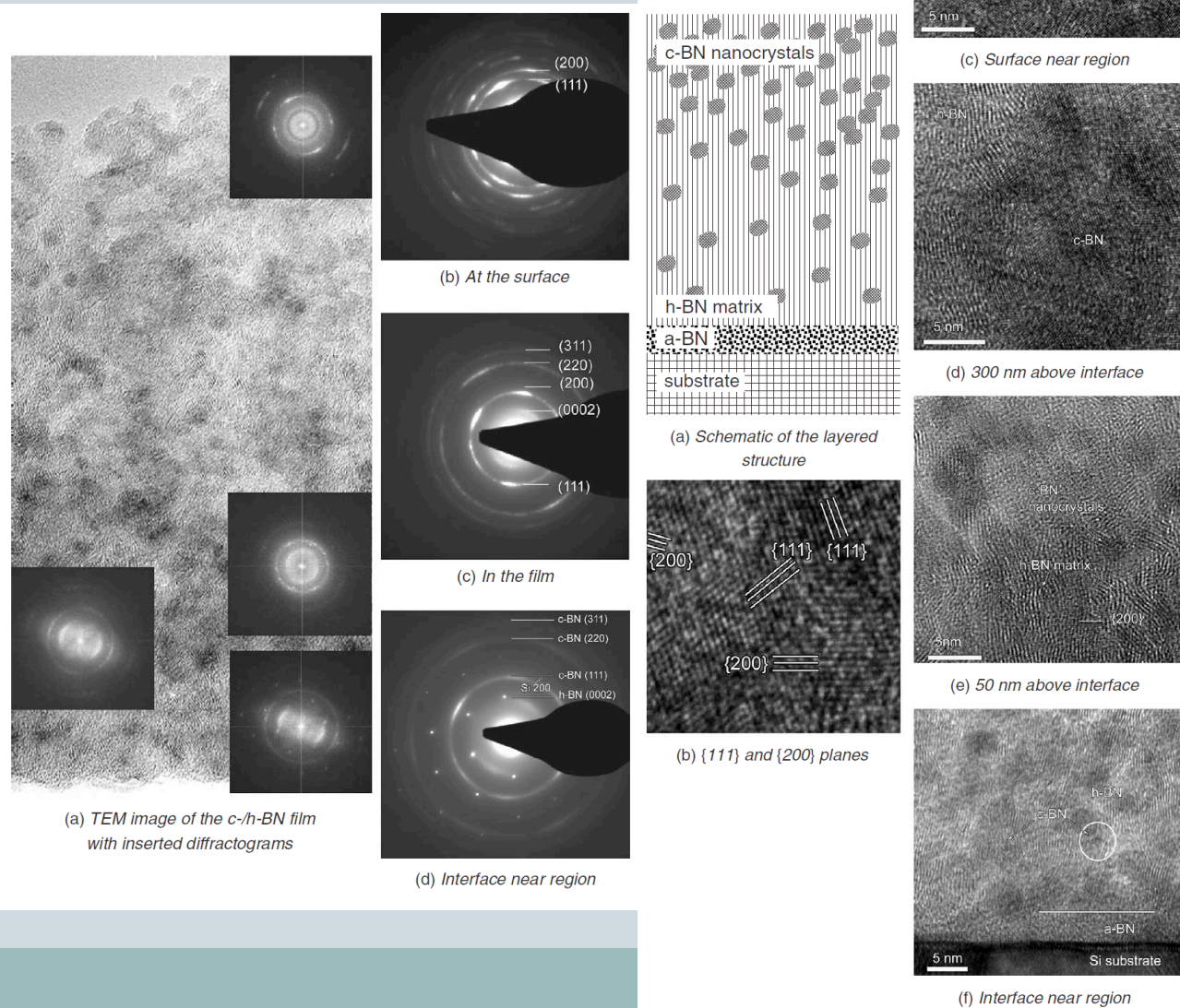
Marti et al. 2007

Revestimento nanocompósito com c-BN e h-BN



Table 1
Lattice plane spacing determined from SAED pattern in Fig. 3 compared with the theoretical values

Lattice plane spacing (nm)	Assignment/theoretical value (nm)
0.336	h-BN (0002)/0.333
0.212	c-BN (111)/0.209
0.182	c-BN (200)/0.181
0.122	c-BN (220)/0.128
0.122	c-BN (311)/0.109
0.092	c-BN (400)/0.090
0.084	c-BN (331)/0.083

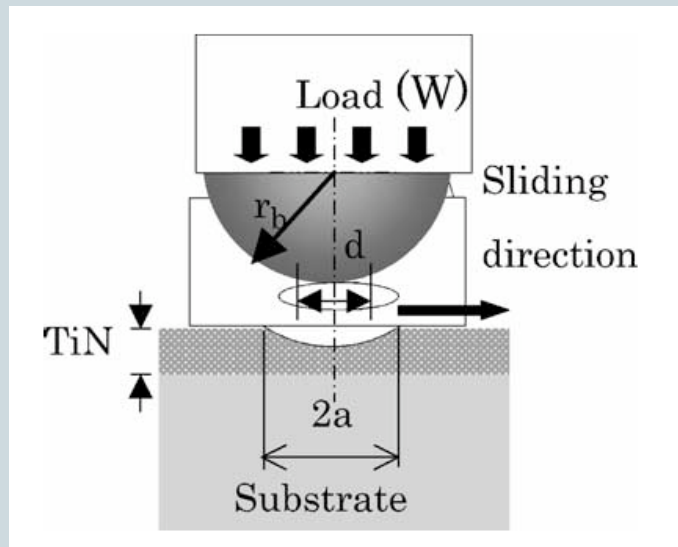


Lattemann et al. (2006)

Revestimento de TiN com Cl implantado



Esfera de Aço INOX 304 ($r = 3 \text{ mm}$)
 $W - 2-5 \text{ N}$
Velocidade – $0,005-0,15 \text{ m/s}$



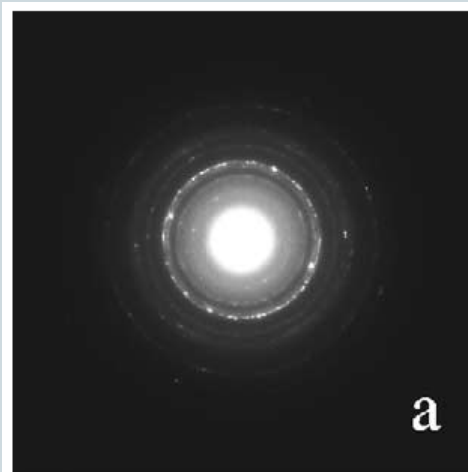
	As-deposited TiN	Ar-implanted TiN	Cl-implanted TiN
Friction coefficient	0.8–1.2	~ 1.0	~ 0.2
Wear coefficient	$\sim 10^{-5}$ to 10^{-4}	$\sim 10^{-4}$	$\sim 10^{-7}$ to 10^{-6}
Wear volume	$\sim 10^{-11} \text{ m}^3$	$\sim 10^{-11} \text{ m}^3$	$\sim 10^{-13} \text{ m}^3$
Wear mode	Adhesive	Adhesive with sticking mode	Abrasive

Akhadejdamrong et al. (2003)

Revestimento de TiN com Cl implantado

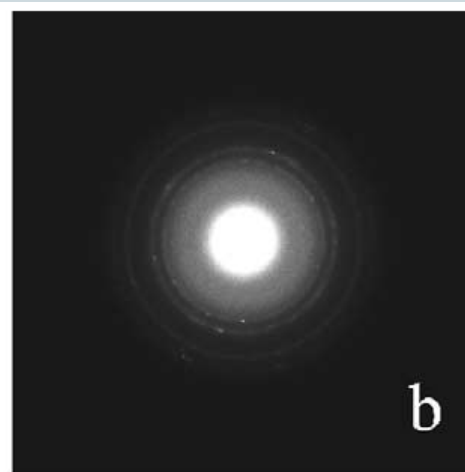


$\text{TiO}_{1,04}, \text{Ti}_7\text{O}_{13}, \text{TiO}_2$



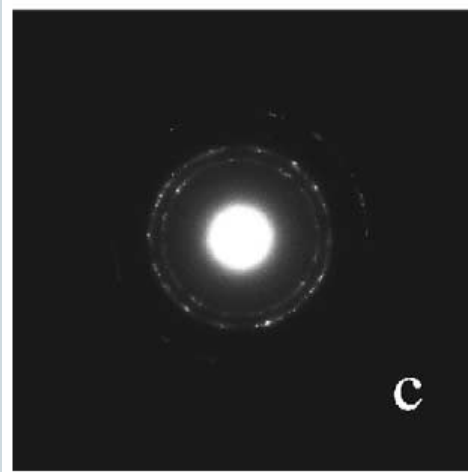
a

$\text{TiO}_{1,04}, \text{Ti}_4\text{O}_7$



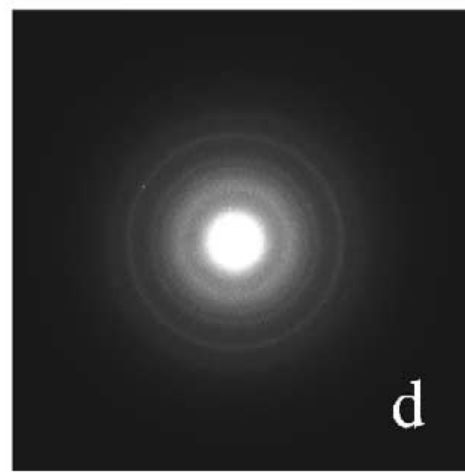
b

$\text{TiO}_{1,04}$



c

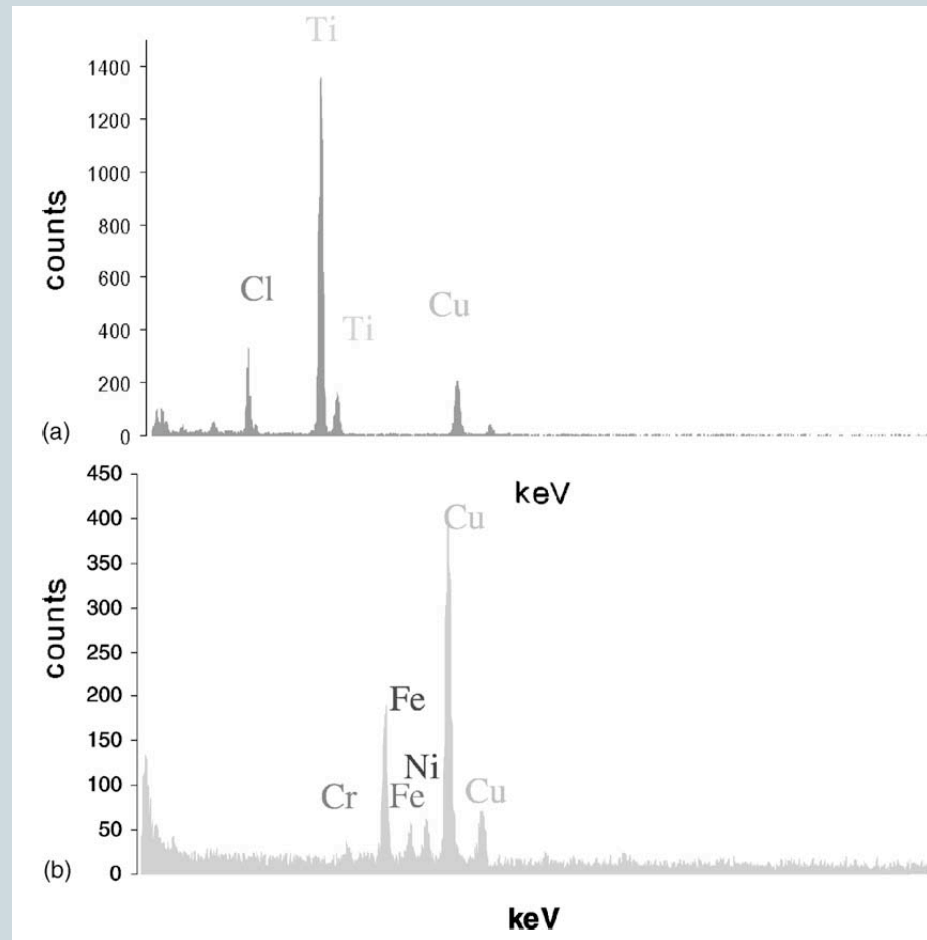
$\text{TiO}_{1,04}, \text{Ti}_4\text{O}_7,$
 $\text{Ti}_5\text{O}_9, \text{TiO}_2$



d

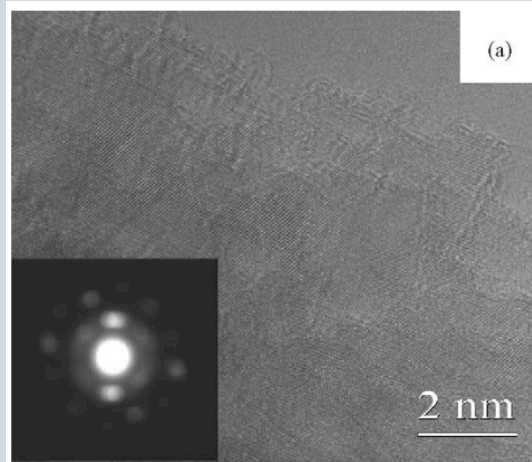
Akhadejdamrong et al. (2003)

Revestimento de TiN com Cl implantado

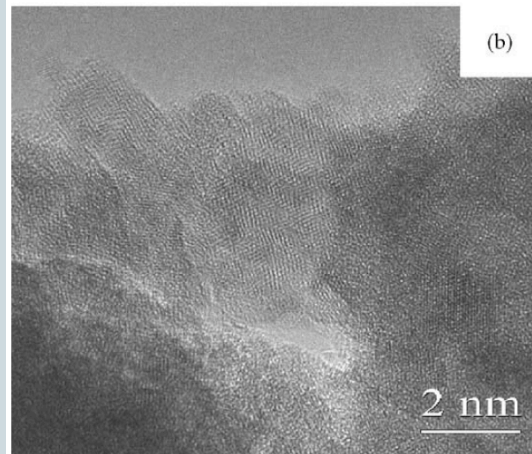
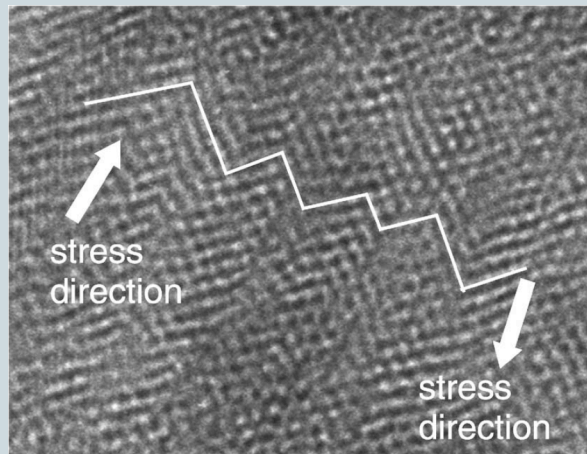


Akhadejdamrong et al. (2003)

Revestimento de TiN com CI implantado



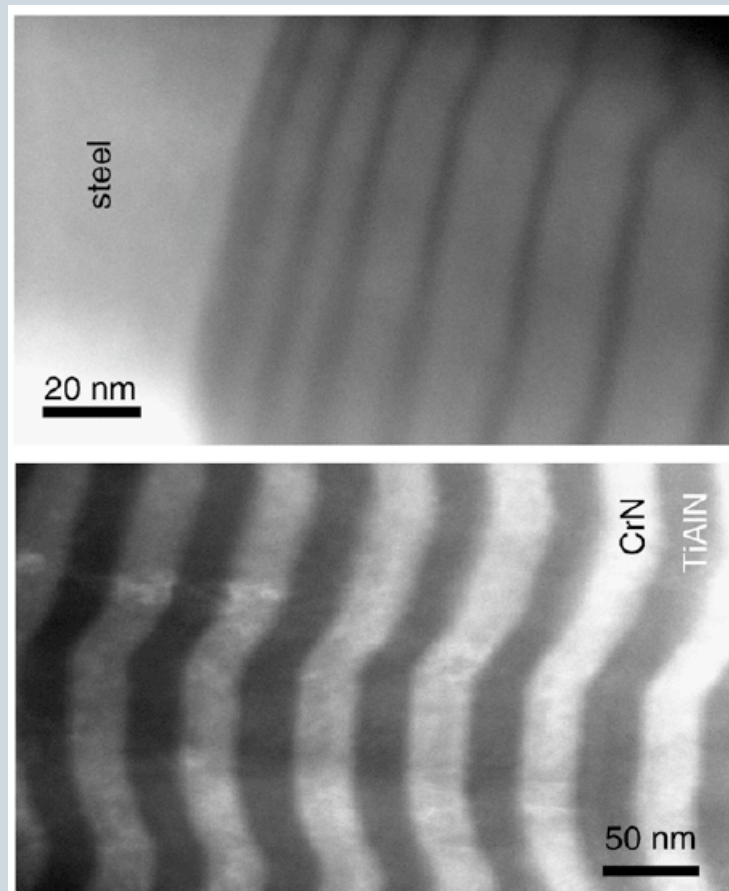
Partícula sem deformação



Partícula com padrões de chevron fruto da maclagem para acomodar a deformação cisalhante

Akhadejdamrong et al. (2003)

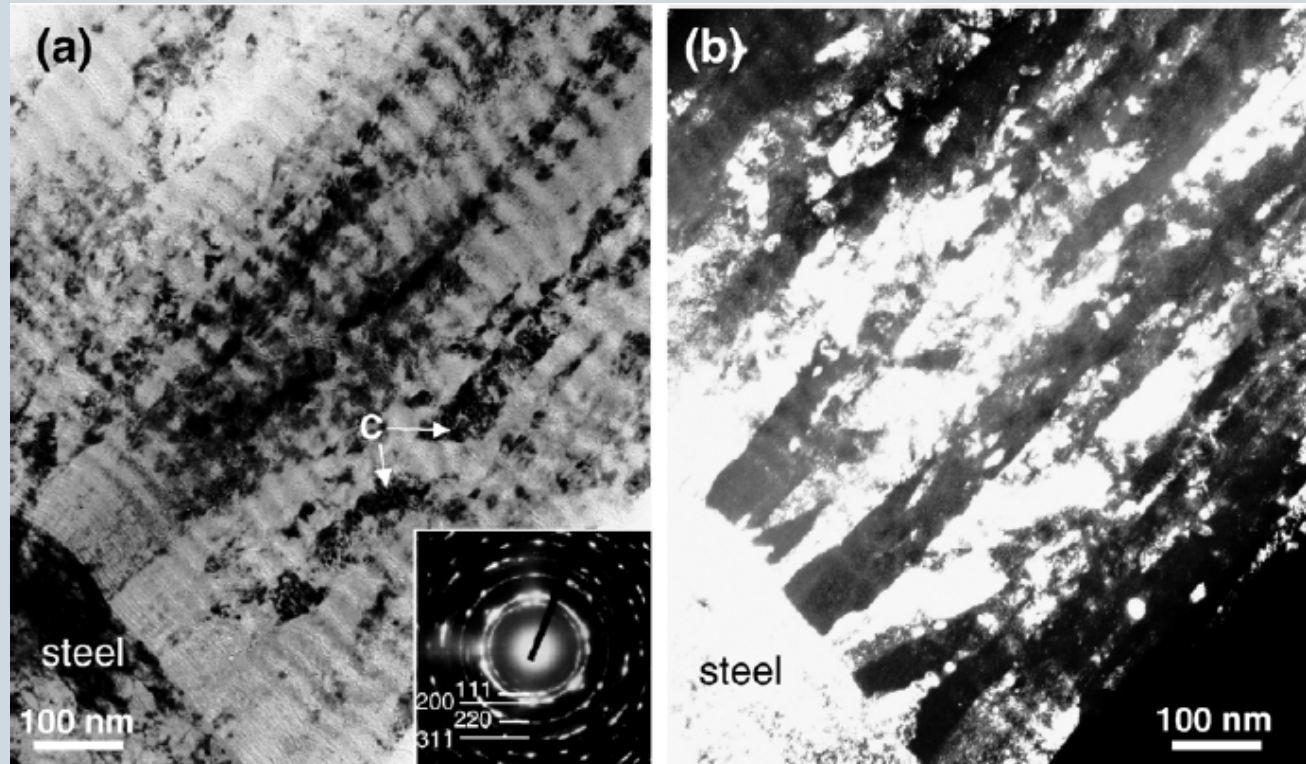
Revestimento Multicamada de TiAlN/CrN



HAADF STEM de camadas de TiAlN/CrN (claro CrN. escuroTiAlN)

Panjan et al. (2007)

Revestimento Multicamada de TiAlN/CrN



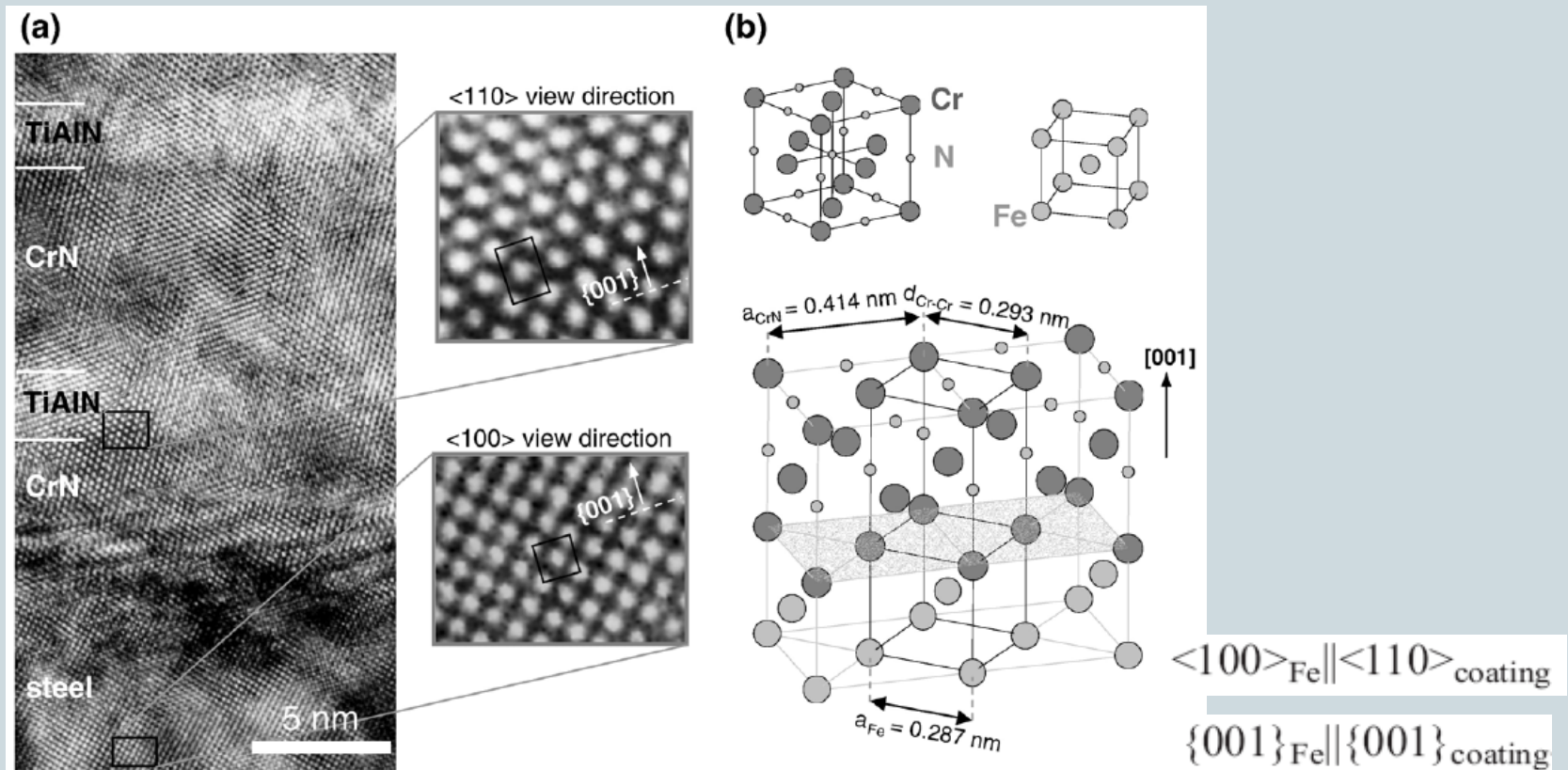
Campo claro

Campo escuro

TiAlN/CrN sobre aço depositado por magnetron sputtering reativo

Panjan et al. (2007)

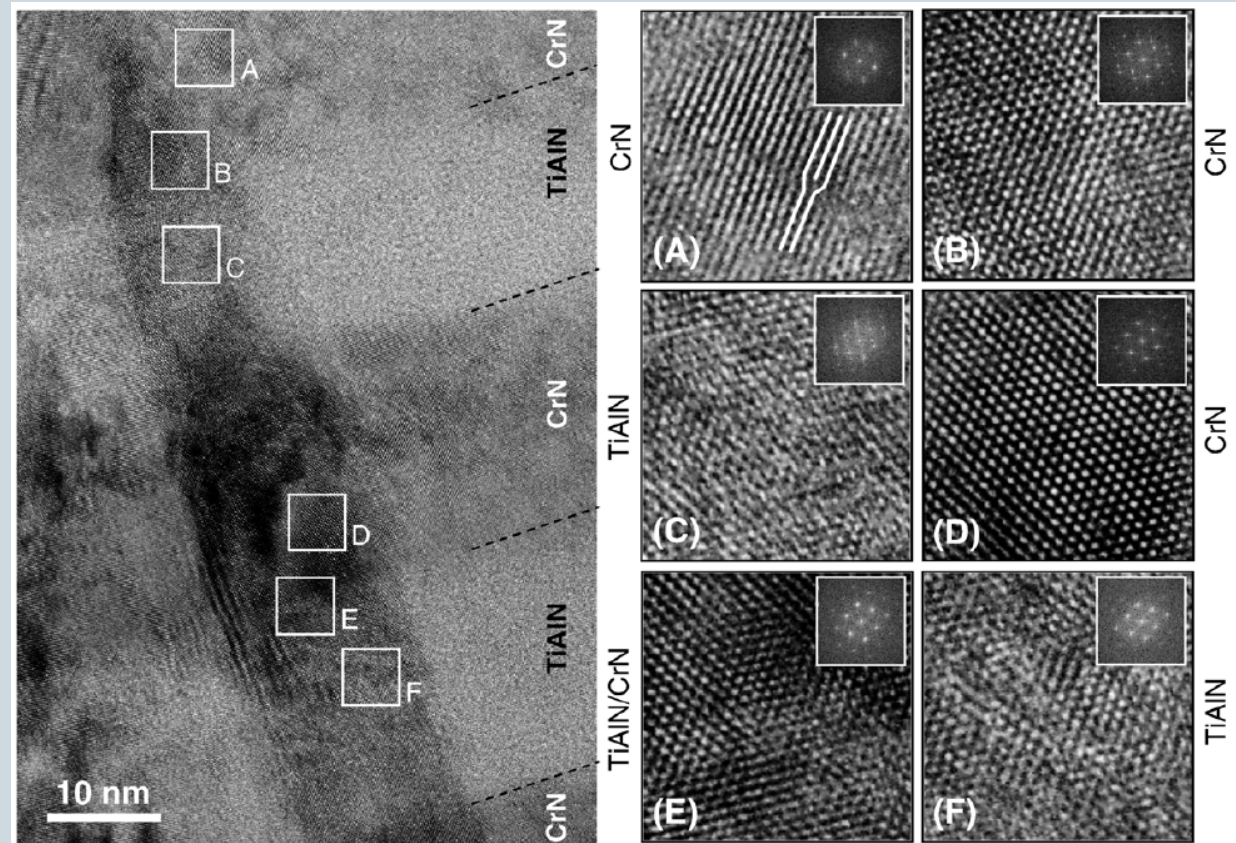
Revestimento Multicamada de TiAlN/CrN



Camadas alternadas de TiAlN e CrN sobre aço. Relação de epitaxia observada

Panjan et al. (2007)

Revestimento Multicamada de TiAlN/CrN



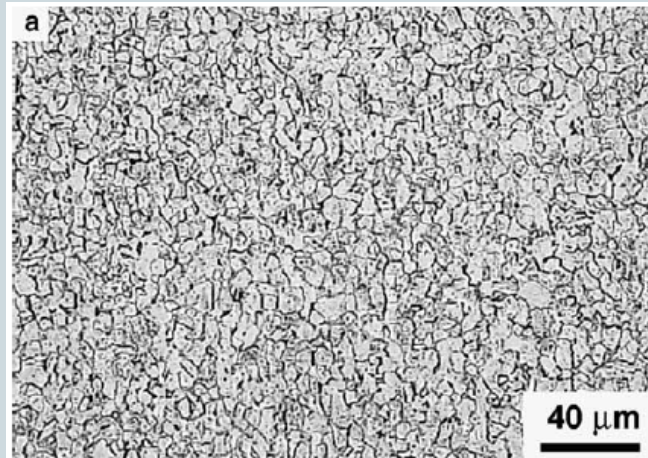
Observação ao longo de um grão colunar, nota-se a epitaxia das camadas ao longo do grão. A-F mostram detalhes em alta resolução, caixas mostram a Transformada de Fourier de cada região.

Panjan et al. (2007)

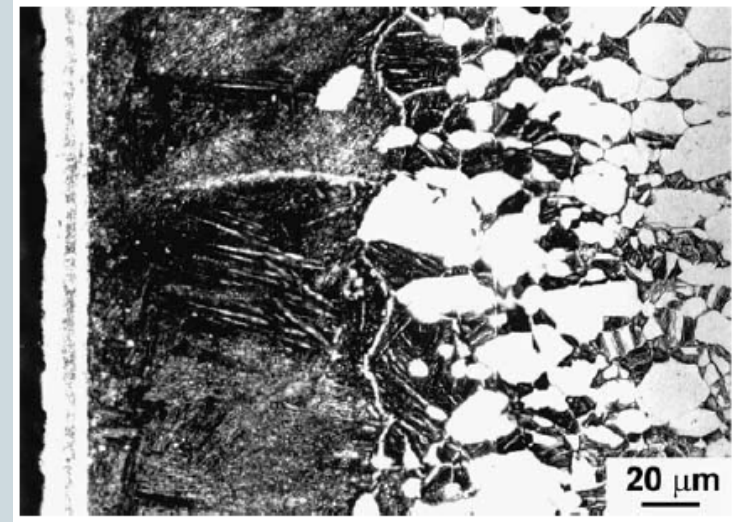
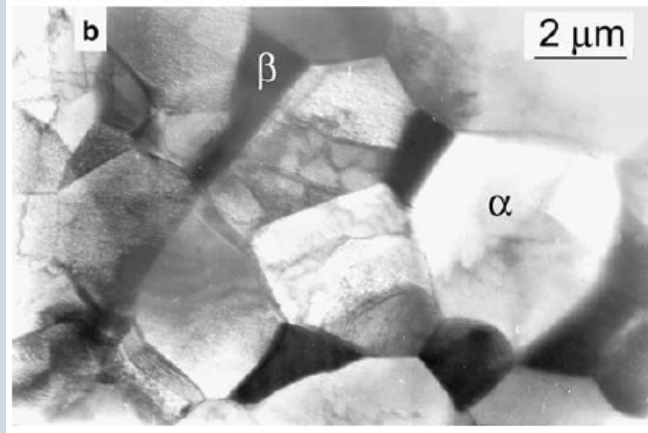
Liga Ti6Al4V com Revestimento Duplex



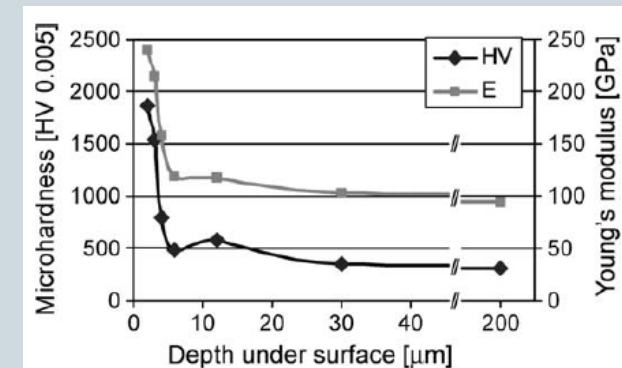
Liga base (MO)



Liga base (TEM)

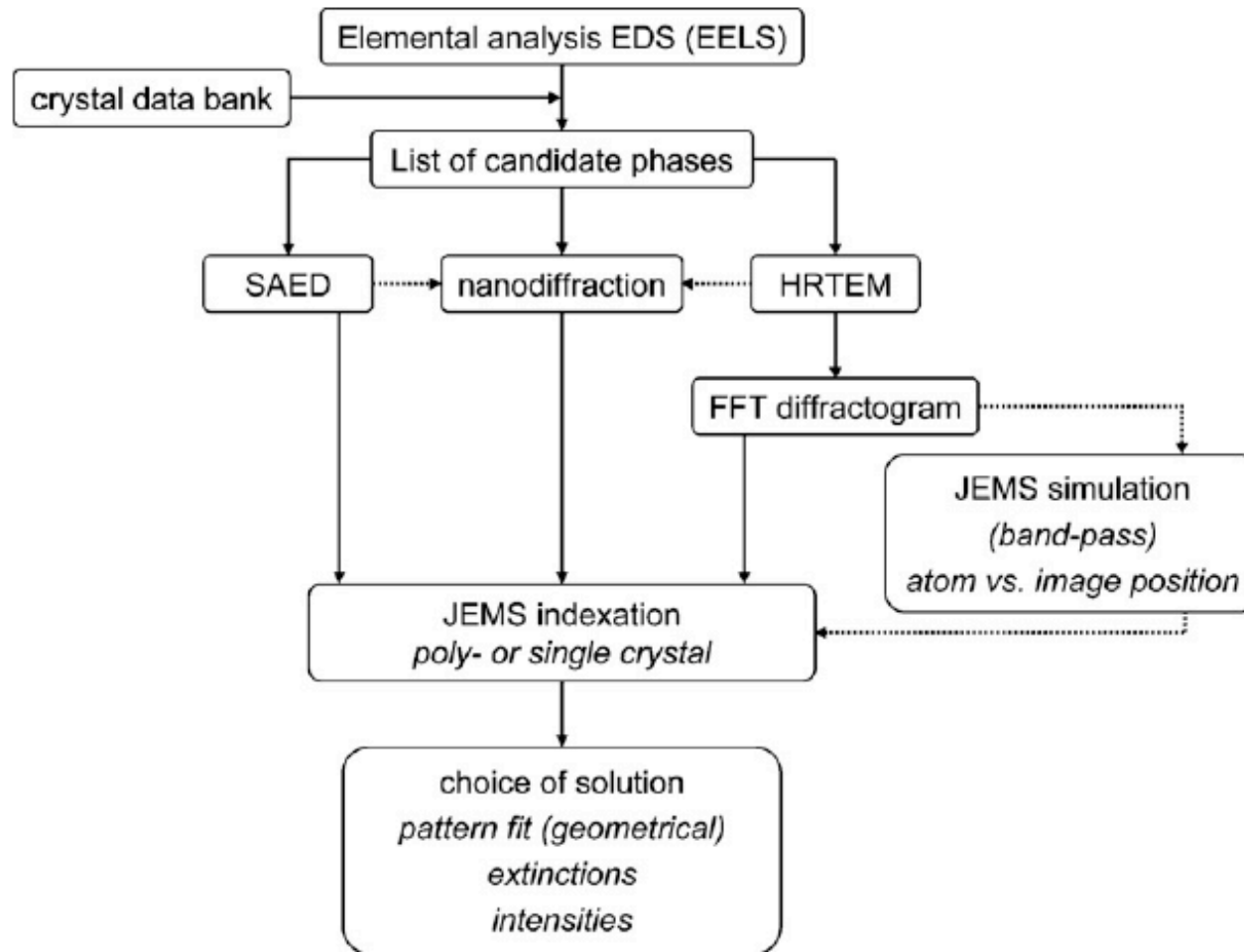


Revestimento (MO)



Czyrska-Flemonowicz et al. (2005)

Fluxograma de Identificação



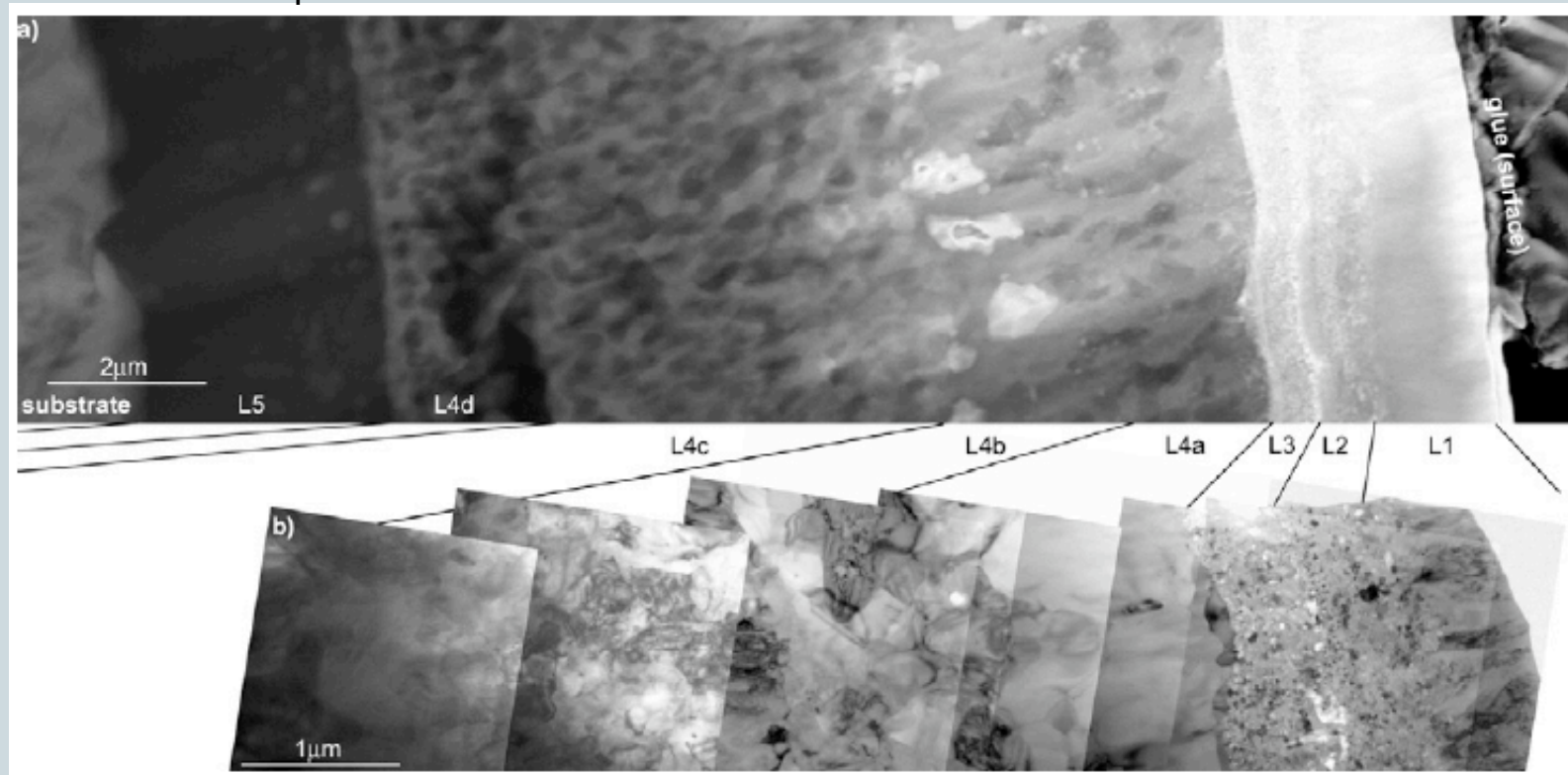
Czyrska-Flemonowicz
e Buffat (2009)

Liga Ti6Al4V com Revestimento Duplex



Camadas L5-L1 distintas do revestimento

EDS possibilitou apenas identificar a presença de Ti, Ni, Al, P e O, levando à possibilidade de 27 diferentes fases possíveis



Czyrska-Flemonowicz e Buffat (2009)

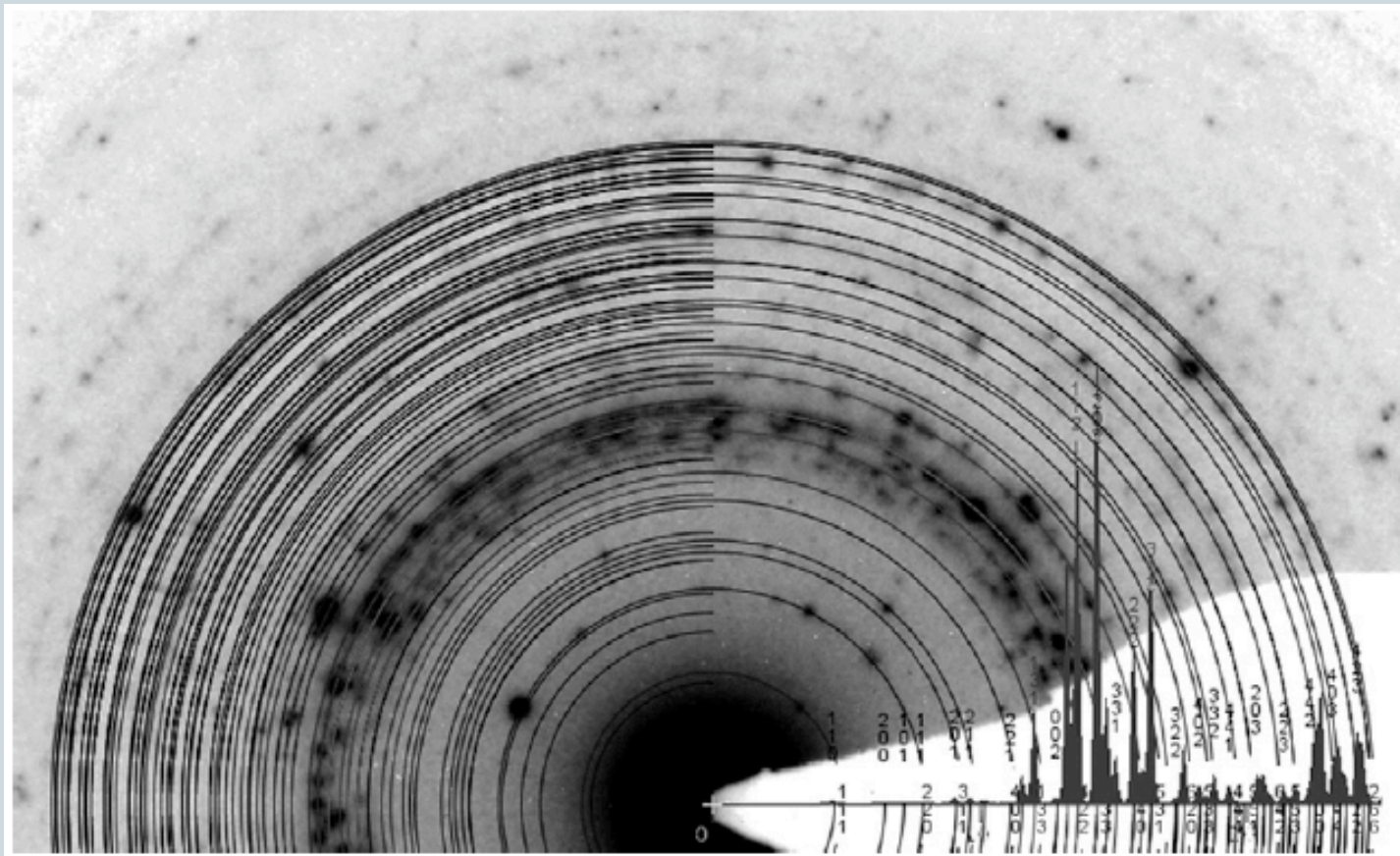
Liga Ti6Al4V com Revestimento Duplex



L1 - NiTi_2 EDS + SAED

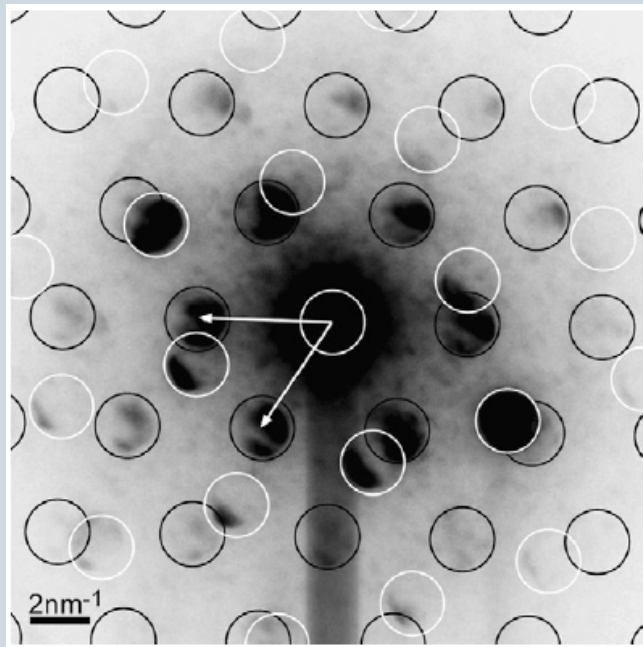
L2 e L3

NiTi_2 (linhas cheias) + TiP_3 (meias linhas)



Czyrska-Flemonowicz e Buffat (2009)

Liga Ti6Al4V com Revestimento Duplex



No interior de L2 foi possível observar pequenas fases, cuja identificação indicou para os círculos pretos Ti_2NiP_5 e para os círculos brancos, Ti_2NiP_5 , Ti_5P_3 ou TiO .

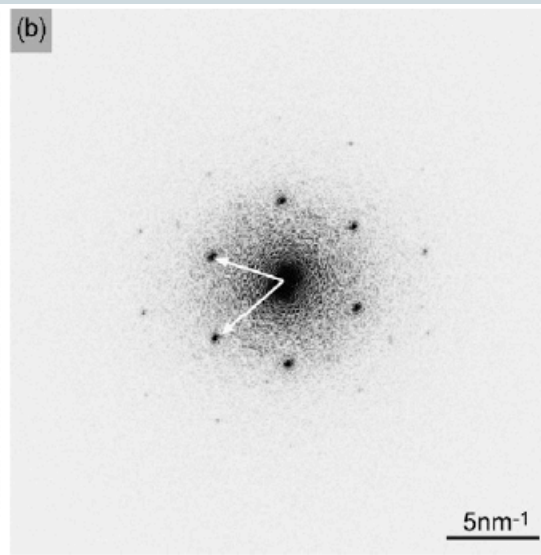
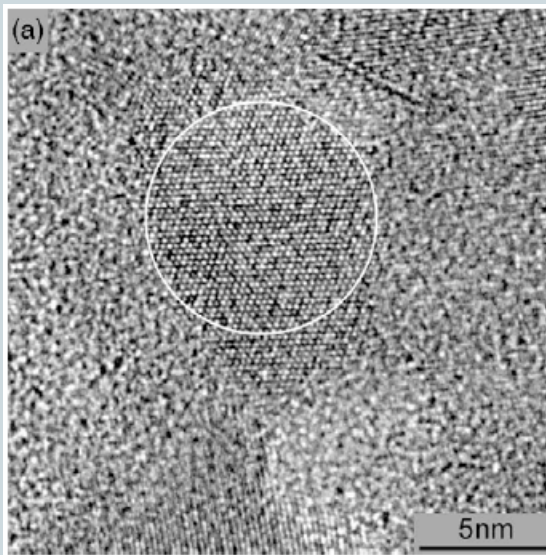
L1	NiTi_2
L2	Major: NiTi_2 , Ti_3P ; minor: TiO ; possible: Ti_5P_3 , Ti_2NiP_5 , AlNi_2Ti , N-Ti-(Al)-O
L3	Ni_2Ti , Ti_3P ; possible: Ni_3Ti , Ti_5P_3 , Ti_2NiP_5
L4/sublayer (a)–(d)	(a) Major: TiNiP ; minor: Ni_3Ti , Ti_5P_3 ; (b) Ni_3Ti , TiNiP , AlNi_2Ti ; (c) AlNi_2Ti ; (d) NiTi_2 , Ti_2P , AlNi_2Ti , $\text{Ni}_5\text{Ti}_3\text{Al}$
L5	Major: NiTi_2 ; isolated precipitates in a sublayer: Ti_3P

Czyrska-Flemonowicz e Buffat (2009)

Liga Ti6Al4V com Revestimento Duplex



Outra possibilidade é obter imagens de alta resolução e construir a Transformada de Fourier, embora seja perdida a informação relativa ao fator de estrutura presente na figura de difração.

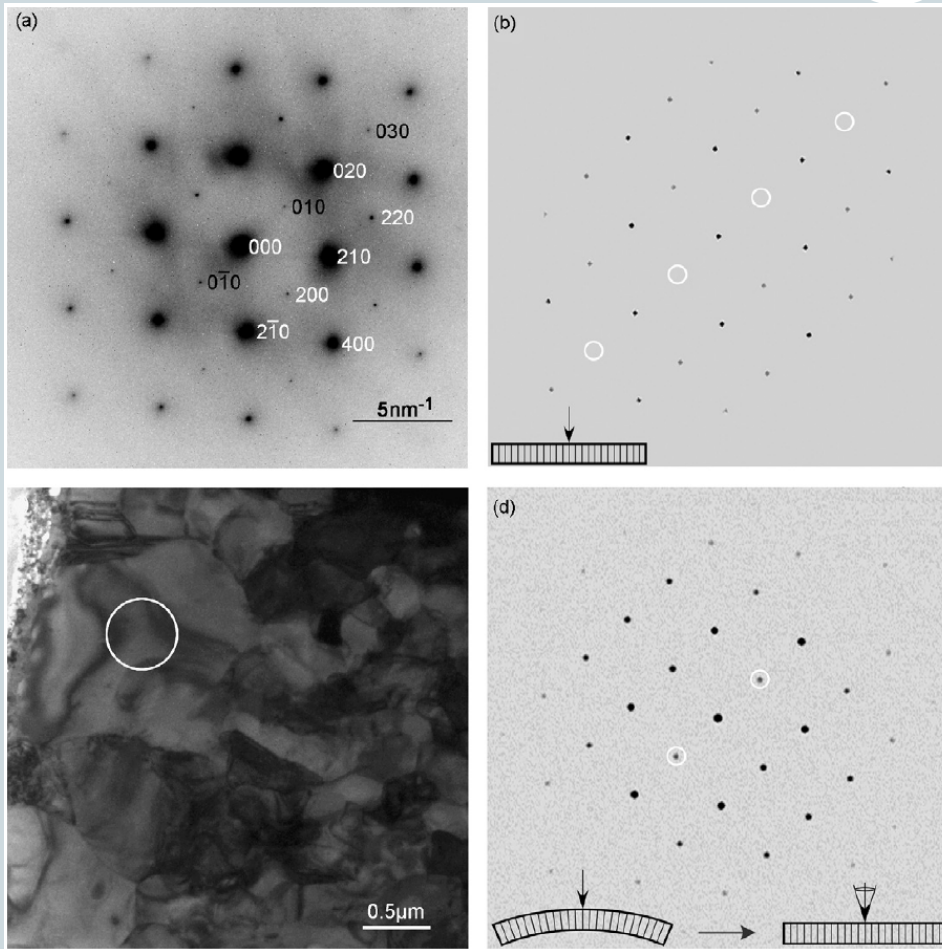


Transformada de Fourier

Padrão de Difração
ideal de Ti_2NiP_5

Czyrska-Flemonowicz e Buffat (2009)

Liga Ti6Al4V com Revestimento Duplex



Em L4, a fase preponderante era NiTiP, embora a mesma estivesse deformada, levando à presença de contornos de distorção e da colocação do plano (010) na condição de Bragg

Czyrska-Flemonowicz e Buffat (2009)

Metamaterials a partir de NPs

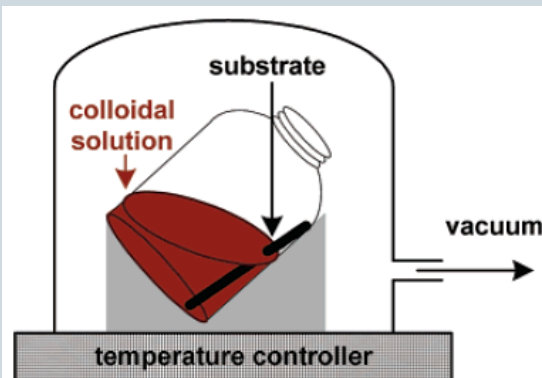


Table 1. Nanoparticles Used as Building Blocks for BNSLs

NPs	size of crystalline core (nm)	std. %	capping ligand	effective thickness of ligand shell ^a (nm)
Pd	3.0	7	dodecanethiol	0.85
	3.4	8		
Ag	3.6	7		
	4.2	6		
Au	5	7	oleic acid	0.75
	5.8	5		0.9
PbSe	6.2	5		0.85
	7.2	6		
	7.6	5		
CoPt ₃	6.2	7	ADA, HDA ^b	1
PbS	6.7	5	oleic acid	0.85
γ -Fe ₂ O ₃	13.4	6		0.9

Table 2. Maximum Packing Density and Range of Stability Calculated for Binary Lattices of Hard Spheres

stoichiometry	type of structure	maximum packing density (γ)	range of stability	ref
AB	NaCl	0.793 (0.414)	below 0.458	27
			$0.2 \leq \gamma \leq 0.42$	25
AB ₂	NiAs	0.793 (~ 0.4)	~ 0.4	59
	CsCl	0.729, unstable	0.732	60
	AlB ₂	0.778(0.58)	$0.482 \leq \gamma \leq 0.624$	27
			$0.42 \leq \gamma \leq 0.59$	25
	Laves phases; hexagonal: MgZn ₂ , MgNi ₂	0.71 (0.813)	$0.606 \leq \gamma \leq 0.952$	27
	cubic MgCu ₂	unstable		
AB ₁₃	CaF ₂	0.757	0.225	25
		unstable		
	NaZn ₁₃ (ico-AB ₁₃)	0.738 (0.58)	$0.54 \leq \gamma \leq 0.61$	25
	ico-AB ₁₃ , with some size distribution for B spheres	above 0.755	$0.474 \leq \gamma \leq 0.626$	23,24
	cub-AB ₁₃	0.700 (0.565)	$0.537 \leq \gamma \leq 0.583$	27
			unstable	27

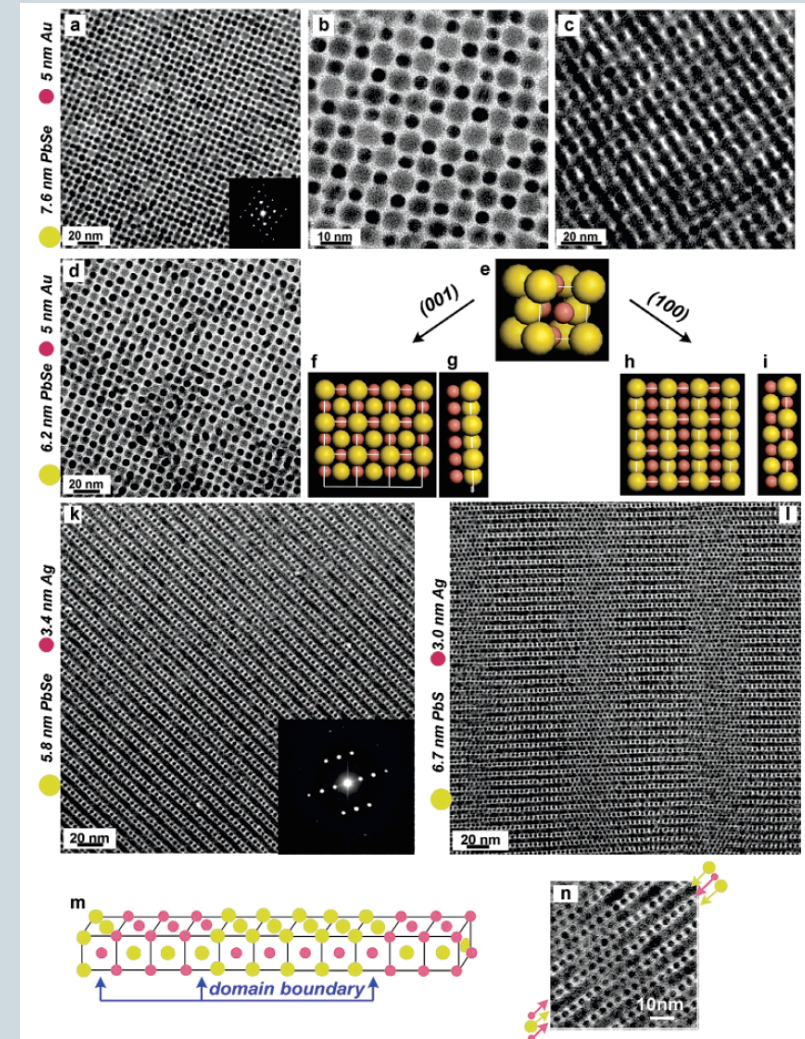
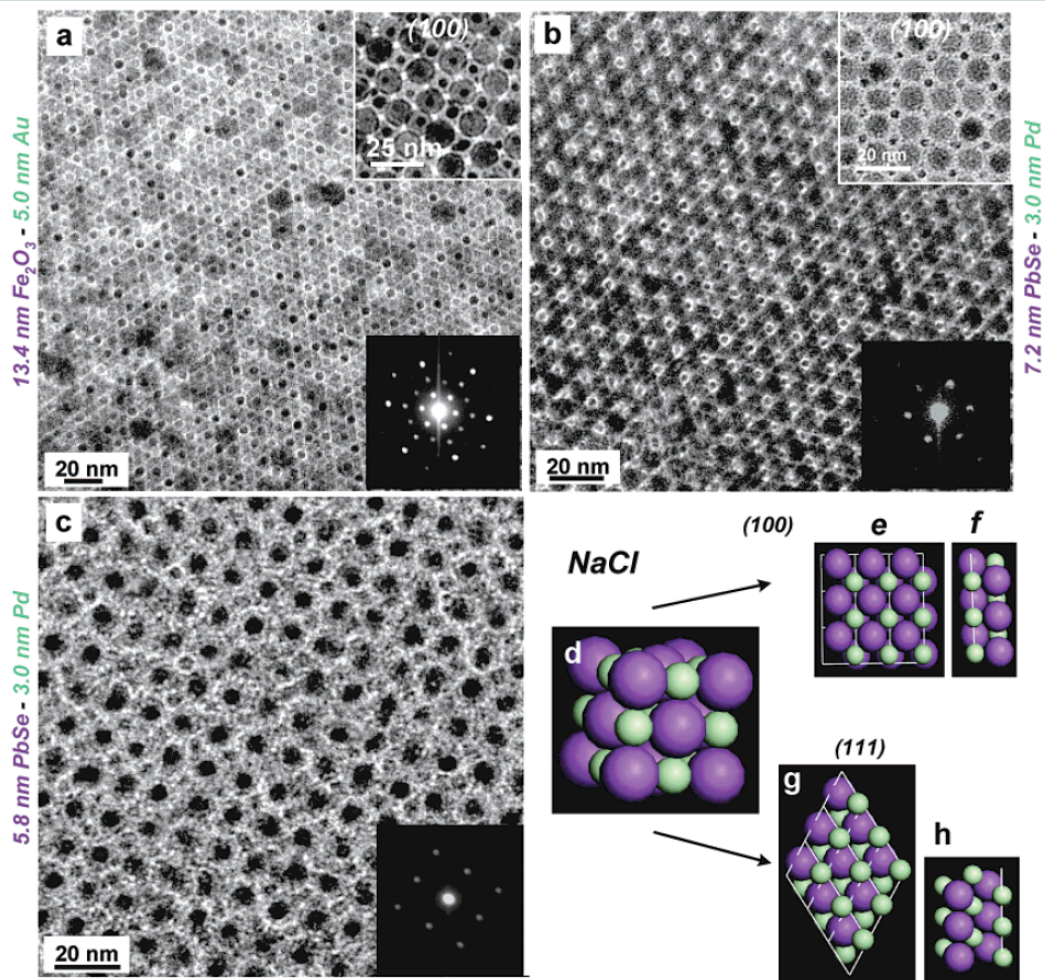


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- Obrigado pela atenção

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